

A29DL32x Series

32 Megabit (4M x 8-Bit/2M x 16-Bit) CMOS 3.0 Volt-only, Simultaneous Operation Flash Memory

Document Title

Preliminary

4M X 8 Bit / 2M X 16 Bit CMOS 3.0 Volt-only, Boot Sector Flash Memory

Revision History

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32 Megabit (4M x 8-Bit/2M x 16-Bit) CMOS 3.0 Volt-only,

Preliminary

Simultaneous Operation Flash Memory

DISTINCTIVE CHARACTERISTICS

ARCHITECTURAL ADVANTAGES

- Simultaneous Read/Write operations
 - Data can be continuously read from one bank while executing erase/program functions in other bank
 - Zero latency between read and write operations
- Multiple bank architectures
 - Three devices available with different bank sizes (refer to Table 2)
- Package options
- 48-ball TFBGA
- 48-pin TSOP
- Top or bottom boot block
- Manufactured on 0.18 µm process technology
 Compatible with AMD AM29DL32xD device
- Compatible with JEDEC standards
 - Pinout and software compatible with single-power-supply flash standard

PERFORMANCE CHARACTERISTICS

- High performance
 - Access time as fast as 70ns
- Program time: 7µs/word typical utilizing Accelerate function
- Ultra low power consumption (typical values)
 - 2mA active read current at 1MHz
 - 10mA active read current at 5MHz
 - 200nA in standby or automatic sleep mode
- Minimum 1 million write cycles guaranteed per sector
- 20 Year data retention at 125°C
- Reliable operation for the life of the system

SOFTWARE FEATURES

- Supports Common Flash Memory Interface (CFI)
- Erase Suspend/Erase Resume
- Suspends erase operations to allow programming in same bank
- Software temporary sector/sector block unprotect command
- Software sector protect/unprotect command

- Data Polling and Toggle Bits
 Provides a software method of detecting the status of program or erase cycles
- Unlock Bypass Program command
 - Reduces overall programming time when issuing multiple program command sequences

HARDWARE FEATURES

- Any combination of sectors can be erased
- Ready/Busy output (RY/BY)
 - Hardware method for detecting program or erase cycle completion
- Hardware reset pin (RESET)
 - Hardware method of resetting the internal state machine to reading array data
- WP /ACC input pin
 - Write protect ($\overline{\rm WP}$) function allows protection of two outermost boot sectors, regardless of sector protect status
- Acceleration (ACC) function accelerates program timing
- Sector protection
 - Hardware method of locking a sector, either in-system or using programming equipment, to prevent any program or erase operation within that sector
 - Temporary Sector Unprotect allows changing data in protected sectors in-system





GENERAL DESCRIPTION

The A29DL32x family consists of 32 megabit, 3.0 volt-only flash memory devices, organized as 2,097,152 words of 16 bits each or 4,194,304 bytes of 8 bits each. Word mode data appears on I/Oo–I/O15; byte mode data appears on I/Oo–I/O7. The device is designed to be programmed in-system with the standard 3.0 volt VCC supply, and can also be programmed in standard EPROM programmers.

The device is available with an access time of 70, 80, 90, or 120 ns. The devices are offered in 48-pin TSOP and 48-ball Fine-pitch TFBGA. Standard control pins—chip enable (\overline{CE}),

write enable ($\overline{\text{WE}}$), and output enable ($\overline{\text{OE}}$)—control normal read and write operations, and avoid bus contention issues.

The device requires only a **single 3.0 volt power supply** for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations.

Simultaneous Read/Write Operations with Zero Latency

The Simultaneous Read/Write architecture provides **simultaneous operation** by dividing the memory space into two banks. The device can improve overall system performance by allowing a host system to program or erase in one bank, then immediately and simultaneously read from the other bank, with zero latency. This releases the system from waiting for the completion of program or erase operations.

The A29DL32x devices use multiple bank architectures to provide flexibility for different applications. Three devices are available with these bank sizes:

| Device | Bank 1 | Bank 2 |
|--------|--------|--------|
| DL322 | 4 Mb | 28 Mb |
| DL323 | 8 Mb | 24 Mb |
| DL324 | 16 Mb | 16 Mb |

A29DL32x Features

The device offers complete compatibility with the **JEDEC single-power-supply Flash command set standard**. Commands are written to the command register using standard microprocessor write timings. Reading data out of the device is similar to reading from other Flash or EPROM devices.

The host system can detect whether a program or erase operation is complete by using the device **status bits:** RY/\overline{BY} pin, I/O_7 (Data Polling) and $I/O_6/I/O_2$ (toggle bits). After a program or erase cycle has been completed, the device automatically returns to reading array data.

The **sector erase architecture** allows memory sectors to be erased and reprogrammed without affecting the data contents of other sectors. The device is fully erased when shipped from the factory.

Hardware data protection measures include a low VCC detector that automatically inhibits write operations during power transitions. The **hardware sector protection** feature disables both program and erase operations in any combination of the sectors of memory. This can be achieved in-s y s t e m or via programming equipment.

The device offers two power-saving features. When addresses have been stable for a specified amount of time, the device enters the **automatic sleep mode**. The system can also place the device into the **standby mode**. Power consumption is greatly reduced in both modes.



Pin Configurations

TSOP (I)



TFBGA





Block Diagram



Pin Descriptions

| Pin M | lo. | Description | | |
|-------------|-----------|---|--|--|
| A0 – / | 420 | Address Inputs | | |
| I/Oo - I | /014 | Data Inputs/Outputs | | |
| | I/O15 | Data Input/Output, Word Mode | | |
| I/O15 (A-1) | A-1 | LSB Address Input, Byte Mode | | |
| CE | | Chip Enable | | |
| WE | | Write Enable | | |
| OE | | Output Enable | | |
| WP // | ACC | Hardware Write Protect/Acceleration Pin | | |
| RES | ET | Hardware Reset Pin, Active Low | | |
| BYT | E | Selects 8-bit or 16-bit Mode | | |
| RY/Ē | <u>BY</u> | Ready/BUSY Output | | |
| VSS | | Ground | | |
| VC | 0 | 3.0 volt-only single power supply | | |
| NC | ; | Pin Not Connected Internally | | |

Logic Symbol





DEVICE BUS OPERATIONS

This section describes the requirements and use of the device bus operations, which are initiated through the internal command register. The command register itself does not occupy any addressable memory location. The register is composed of latches that store the commands, along with the address and data information needed to execute the

command. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device. The appropriate device bus operations table lists the inputs and control levels required, and the resulting output. The following subsections describe each of these operations in further detail.

| Operation | CE | ŌE | WE | RESET | WP/ACC | A0 – A20 | I/O ₀ - I/O ₇ | I/O | 98 - I/O 15 |
|----------------------------------|-------------|----|----|-------------|----------|-------------------------|---|----------|--------------------|
| | | | | | | (Note 1) | | BYTE =V⊮ | BYTE =V⊩ |
| Read | L | L | Н | н | L/H | Ain | Dout | Dout | I/O8~I/O15=High-Z |
| Write | L | Н | L | н | (Note 3) | Ain | Din | Din | I/O8~I/O14=High-Z |
| | | | | | | | | | I/O15=A-1 |
| Standby | VCC ± 0.3 V | Х | Х | VCC ± 0.3 V | Н | Х | High-Z | High-Z | High-Z |
| Output Disable | L | Н | Н | н | L/H | Х | High-Z | High-Z | High-Z |
| Reset | Х | Х | Х | L | L/H | Х | High-Z | High-Z | High-Z |
| Sector Protect (See Note 2) | L | Н | L | Vid | L/H | SA, A6=L, A1=H, A0=L | Dіn | Х | Х |
| Sector Unprotect (See Note 2) | L | Н | L | Vid | (Note 3) | SA, A6=H, A1=H, A0=L | Dіn | Х | Х |
| Temporary Sector Unprotect | Х | Х | Х | Vid | (Note 3) | Ain | Din | Din | High-Z |

Table 1. A29DL32x Device Bus Operations

Legend:

L = Logic Low = VIL, H = Logic High = VIH, VID = 8.5 -12.5V, VHH = 9.0 \pm 0.5 V, X = Don't Care, SA = Sector Address, AIN = Address In, DIN= Data In, DOUT = Data Out

Notes:

1. Addresses are A20:A0 in word mode ($\overline{BYTE} = V_{H}$), A20: A-1 in byte mode ($\overline{BYTE} = V_{L}$).

2. The sector protect and sector unprotect functions may also be implemented via programming equipment. See the "Sector/Sector Block Protection and Unprotection" section.

3. If WP /ACC = VIL, the two outermost boot sectors remain protected. If WP /ACC = VIH, the two outermost boot sector protection depends on whether they were last protected or unprotected using the method described in "Sector/Sector Block Protection and Unprotection". If WP /ACC = VHH all sectors will be unprotected.



Word/Byte Configuration

The \overrightarrow{BYTE} pin determines whether the I/O pins I/O15-I/O0 operate in the byte or word configuration. If the \overrightarrow{BYTE} pin is set at logic "1", the device is in word configuration, I/O15-I/O0 are active and controlled by \overrightarrow{CE} and \overrightarrow{OE} .

If the \overrightarrow{BYTE} pin is set at logic "0", the device is in byte configuration, and only I/Oo-I/O7 are active and controlled by \overrightarrow{CE} and \overrightarrow{OE} . I/O8-I/O14 are tri-stated, and I/O15 pin is used as an input for the LSB(A-1) address function.

Requirements for Reading Array Data

To read array data from the outputs, the system must drive the \overline{CE} and \overline{OE} pins to VIL. \overline{CE} is the power control and selects the device. \overline{OE} is the output control and gates array data to the output pins. \overline{WE} should remain at VIH. The \overline{BYTE} pin determines whether the device outputs array data in words or bytes.

The internal state machine is set for reading array data upon device power-up, or after a hardware reset. This ensures that no spurious alteration of the memory content occurs during the power transition. No command is necessary in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. Each bank remains enabled for read access until the command register contents are altered.

See "Requirements for Reading Array Data" for more information. Refer to the AC Read-Only Operations table for timing specifications and to Figure 11 for the timing waveform, lcc1 in the DC Characteristics table represents the active current specification for reading array data.

Writing Commands/Command Sequences

To write a command or command sequence (which includes programming data to the device and erasing sectors of memory), the system must drive \overline{WE} and \overline{CE} to V_{IL}, and $\overline{\overline{OE}}$ to V_{IH}.

For program operations, the $\overrightarrow{\text{BYTE}}$ pin determines whether the device accepts program data in bytes or words, Refer to "Word/Byte Configuration" for more information.

The device features an Unlock Bypass mode to facilitate faster programming. Once a bank enters the Unlock Bypass mode, only two write cycles are required to program a word or byte, instead of four. The "Word / Byte Program Command Sequence" section has details on programming data to the device using both standard and Unlock Bypass command sequence.

An erase operation can erase one sector, multiple sectors, or the entire device. The Sector Address Tables 3-4 indicate the address range that each sector occupies. The device address space is divided into two banks: Bank 1 contains the boot/parameter sectors, and Bank 2 contains the larger, code sectors of uniform size. A "bank address" is the address bits required to uniquely select a bank. Similarly, a "sector address" is the address bits required to uniquely select a sector.

Icc2 in the DC Characteristics table represents the active current specification for the write mode. The "AC Characteristics" section contains timing specification tables and timing diagrams for write operations.

Accelerated Program Operation

The device offers accelerated program operations through the ACC function. This is one of two functions provided by the $\overline{\text{WP}}$ /ACC pin. This function is primarily intended to allow faster manufacturing throughput at the factory.

If the system asserts VhH on this pin, the device automatically enters the aforementioned Unlock Bypass mode, temporarily unprotects any protected sectors, and uses the higher voltage on the pin to reduce the time required for program operations. The system would use a two-cycle program command sequence as required by the Unlock Bypass mode. Removing VhH from the \overline{WP} /ACC pin returns the device to normal operation. Note that the \overline{WP} /ACC pin must not be at VhH for operations other than accelerated programming, or device damage may result. In addition, the \overline{WP} /ACC pin must not be left floating or unconnected; inconsistent behavior of the device may result.

Autoselect Functions

If the system writes the autoselect command sequence, the device enters the autoselect mode. The system can then read autoselect codes from the internal register (which is separate from the memory array) on I/O_7 - I/O_0 . Standard read cycle timings apply in this mode. Refer to the Autoselect Mode and Autoselect Command Sequence sections for more information.

Simultaneous Read/Write Operations with Zero Latency

This device is capable of reading data from one bank of memory while programming or erasing in the other bank of memory. An erase operation may also be suspended to read from or program to another location within the same bank (except the sector being erased). Figure 18 shows how read and write cycles may be initiated for simultaneous operation with zero latency. Iccs and Icc7 in the DC Characteristics table represent the current specifications for read-while-program and read-while-erase, respectively.

Standby Mode

When the system is not reading or writing to the device, it can place the device in the standby mode. In this mode, current consumption is greatly reduced, and the outputs are placed in the high impedance state, independent of the \overline{OE} input.

The device enters the CMOS standby mode when the \overline{CE} & \overline{RESET} pins are both held at VCC \pm 0.3V. (Note that this is a more restricted voltage range than VIH.) If \overline{CE} and \overline{RESET} are held at VIH, but not within VCC \pm 0.3V, the device will be in the standby mode, but the standby current will be greater. The device requires the standard access time (tcE) for read access when the device is in either of these standby modes, before it is ready to read data.

If the device is deselected during erasure or programming, the device draws active current until the operation is completed.

Icc3 in the DC Characteristics tables represent the standby current specification.

Automatic Sleep Mode

The automatic sleep mode minimizes Flash device energy consumption. The device automatically enables this mode when addresses remain stable for tacc +30ns. The automatic



sleep mode is independent of the \overline{CE} , \overline{WE} and \overline{OE} control signals. Standard address access timings provide new data when addresses are changed. While in sleep mode, output data is latched and always available to the system. Icc4 in the DC Characteristics table represents the automatic sleep mode current specification.

RESET : Hardware Reset Pin

The RESET pin provides a hardware method of resetting the device to reading array data. When the system drives the RESET pin low for at least a period of tRP, the device immediately terminates any operation in progress, tristates all data output pins, and ignores all read/write attempts for the duration of the RESET pulse. The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once the device is ready to accept another command sequence, to ensure data integrity.

Current is reduced for the duration of the $\overrightarrow{\text{RESET}}$ pulse. When $\overrightarrow{\text{RESET}}$ is held at VSS \pm 0.3V, the device draws CMOS standby current (Icc4). If $\overrightarrow{\text{RESET}}$ is held at VIL but not within VSS \pm 0.3V, the standby current will be greater. The RESET pin may be tied to the system reset circuitry. A system reset would thus also reset the Flash memory, enabling the system to read the boot-up firmware from the Flash memory.

If $\overrightarrow{\text{RESET}}$ is asserted during a program or erase operation, the RY/ $\overrightarrow{\text{BY}}$ pin remains a "0" (busy) until the internal reset operation is complete, which requires a time tready (during Embedded Algorithms). The system can thus monitor RY/ $\overrightarrow{\text{BY}}$ to determine whether the reset operation is complete. If $\overrightarrow{\text{RESET}}$ is asserted when a program or erase operation is not executing (RY/ $\overrightarrow{\text{BY}}$ pin is "1"), the reset operation is completed within a time of tready (not during Embedded Algorithms). The system can read data trn after the $\overrightarrow{\text{RESET}}$ pin return to Vin.

Refer to the AC Characteristics tables for RESET parameters and diagram.

Output Disable Mode

When the \overline{OE} input is at VIH, output from the device is disabled. The output pins are placed in the high impedance state.

Table 2. A29DL32x Device Bank Divisions

| Device | | Bank 1 | Bank 2 | | | |
|-------------|----------|--|----------|----------------------------------|--|--|
| Part Number | Megabits | Sector Sizes | Megabits | Sector Sizes | | |
| A29DL322 | 4 Mbit | Eight 8 Kbyte/4 Kword, seven 64 Kbyte/32 Kword | 28 Mbit | Fifty-six 64 Kbyte/32 Kword | | |
| A29DL323 | 8 Mbit | Eight 8 Kbyte/4 Kword, fifteen 64 Kbyte/32 Kword | 24 Mbit | Forty-eight 64 Kbyte/32 Kword | | |
| A29DL324 | 16 Mbit | Eight 8 Kbyte/4 Kword, Thirty one 64 Kbyte/32 Kword | 16 Mbit | Thirty-two 64 Kbyte/32 Kword | | |



Table 3 Sector Addresses for Top Boot Sector Devices

| A29DL324T | A29DL323T | A29DL322T | Sector | Sector Address A20–A12 | Sector Size (Kbytes/Kwords) | (x8) Address Range | (x16) Address Range |
|-----------|-----------|-----------|--------------|---------------------------|--------------------------------|-----------------------|------------------------|
| | | | SA0 | 000000XXX | 64/32 | 000000h-00FFFFh | 000000h-007FFFh |
| | | | SA1 | 000001XXX | 64/32 | 010000h-01FFFFh | 008000h-00FFFFh |
| | | | SA2 | 000010XXX | 64/32 | 020000h-02FFFFh | 010000h-017FFFh |
| | | | SA3 | 000011XXX | 64/32 | 030000h-03FFFFh | 018000h-1FFFFFh |
| | | | SA4 | 000100XXX | 64/32 | 040000h-04FFFFh | 020000h-027FFFh |
| | | | SA5 | 000101XXX | 64/32 | 050000h-05FFFFh | 028000h-02FFFFh |
| | | | SA6 | 000110XXX | 64/32 | 060000h-06FFFFh | 030000h-037FFFh |
| | | | SA7 | 000111XXX | 64/32 | 070000h-07FFFFh | 038000h-03FFFFh |
| | | | SA8 | 001000XXX | 64/32 | 080000h-08FFFFh | 040000h-047FFFh |
| | | | SA9 | 001001XXX | 64/32 | 090000h-09FFFFh | 048000h-04FFFFh |
| | | | SA10 | 001010XXX | 64/32 | 0A0000h-0AFFFFh | 050000h-057FFFh |
| | | | SA11 | 001011XXX | 64/32 | 0B0000h-0BFFFFh | 058000h-05FFFFh |
| | | | SA12 | 001100XXX | 64/32 | 0C0000h-0CFFFFh | 060000h-067FFFh |
| | | | SA13 | 001101XXX | 64/32 | 0D0000h-0DFFFFh | 068000h-06FFFFh |
| 2 | | | SA14 | 001110XXX | 64/32 | 0E0000h-0EFFFFh | 070000h-077FFFh |
| ¥ | | | SA15 | 001111XXX | 64/32 | 0F0000h-0FFFFFh | 078000h-07FFFFh |
| 3ar | | | SA16 | 010000XXX | 64/32 | 100000h-10FFFFh | 080000h-087FFFh |
| | | | SA17 | 010001XXX | 64/32 | 110000h-11FFFFh | 088000h-08FFFFh |
| | | | SA18 | 010010XXX | 64/32 | 120000h-12FFFh | 090000h-097FFFh |
| | | | SA19 | 010011XXX | 64/32 | 130000h-13FFFFh | 098000h-09FFFFh |
| | | | SA20 | 010100XXX | 64/32 | 140000h-14FFFFh | |
| | | | SA21 | 010101XXX | 64/32 | 150000h-15FFFFh | 0A8000h-0AFFFh |
| | 5 | 2 | SA22 | 010110XXX | 64/32 | 160000h-16FFFh | |
| | ank | hre | SA23 | 010111XXX | 64/32 | 170000h-17FFFh | |
| | ä | ä | SA24 | 011000XXX | 64/32 | 180000h-18FFFFh | |
| | | | 5A25 | 011001XXX | 64/32 | 1900001-19FFFF1 | |
| | | | SA20 | 011010XXX | 64/32 | 120000h-12555 | |
| | | | SA27 | 011100XXX | 64/32 | 100000h-10FFFF1 | |
| | | | SA20 | 011100XXX | 64/32 | 100000h-10FFFF1 | |
| | | | SA29 SA30 | 011107XX | 64/32 | 1E0000h-1EEEEh | |
| | | | SA30 | 011111XXX | 64/32 | 1E0000h-1EFEEh | |
| | | | SA32 | 10000XXX | 64/32 | 200000h-20FFFFh | 100000h-107FFFh |
| | | | SA33 | 100000XXX | 64/32 | 210000h-21FFFFh | 108000h-10FFFFh |
| | | | SA34 | 100010XXX | 64/32 | 220000h-22FFFFh | 110000h-117FFFh |
| | | | SA35 | 100011XXX | 64/32 | 230000h-23FFFFh | 118000h-11FFFFh |
| | | | SA36 | 100100XXX | 64/32 | 240000h-24FFFFh | 120000h-127FFFh |
| | | | SA37 | 100101XXX | 64/32 | 250000h-25FFFFh | 128000h-12FFFFh |
| | | | SA38 | 100110XXX | 64/32 | 260000h-26FFFFh | 130000h–137FFFh |
| ¥ 7 | | | SA39 | 100111XXX | 64/32 | 270000h-27FFFFh | 138000h-13FFFFh |
| an | | | SA40 | 101000XXX | 64/32 | 280000h-28FFFFh | 140000h-147FFFh |
| ш | | | SA41 | 101001XXX | 64/32 | 290000h-29FFFFh | 148000h-14FFFFh |
| | | | SA42 | 101010XXX | 64/32 | 2A0000h-2AFFFFh | 150000h-157FFFh |
| | | | SA43 | 101011XXX | 64/32 | 2B0000h-2BFFFFh | 158000h-15FFFFh |
| | | | SA44 | 101100XXX | 64/32 | 2C0000h-2CFFFFh | 160000h-167FFFh |
| | | | SA45 | 101101XXX | 64/32 | 2D0000h-2DFFFFh | 168000h-16FFFFh |
| | | | SA46 | 101110XXX | 64/32 | 2E0000h-2EFFFFh | 170000h-177FFFh |
| | | | SA47 | 101111XXX | 64/32 | 2F0000h-2FFFFFh | 178000h-17FFFFh |



Table 3 Sector Addresses for Top Boot Sector Devices

| A29DL324T | A29DL323T | A29DL322T | Sector | Sector Address A20–A12 | Sector Size (Kbytes/Kwords) | (x8) Address Range | (x16) Address Range |
|-----------|-----------|-----------|--------|---------------------------|--------------------------------|-----------------------|------------------------|
| | | | SA48 | 110000XXX | 64/32 | 300000h-30FFFFh | 180000h-187FFFh |
| | | | SA49 | 110001XXX | 64/32 | 310000h-31FFFFh | 188000h-18FFFFh |
| | | 2 | SA50 | 110010XXX | 64/32 | 320000h-32FFFFh | 190000h-197FFFh |
| | | k : | SA51 | 110011XXX | 64/32 | 330000h-33FFFFh | 198000h-19FFFFh |
| | | 3an | SA52 | 110100XXX | 64/32 | 340000h-34FFFFh | 1A0000h-1A7FFFh |
| | | ш | SA53 | 110101XXX | 64/32 | 350000h-35FFFFh | 1A8000h-1AFFFFh |
| | | | SA54 | 110110XXX | 64/32 | 360000h-36FFFFh | 1B0000h-1B7FFFh |
| | | | SA55 | 110111XXX | 64/32 | 370000h-37FFFFh | 1B8000h-1BFFFFh |
| | | | SA56 | 111000XXX | 64/32 | 380000h-38FFFFh | 1C0000h-1C7FFFh |
| | | | SA57 | 111001XXX | 64/32 | 390000h-39FFFFh | 1C8000h-1CFFFFh |
| 5 | ۲1 | | SA58 | 111010XXX | 64/32 | 3A0000h-3AFFFFh | 1D0000h-1D7FFFh |
| ank | ank | | SA59 | 111011XXX | 64/32 | 3B0000h-3BFFFFh | 1D8000h-1DFFFFh |
| ä | ä | | SA60 | 111100XXX | 64/32 | 3C0000h-3CFFFFh | 1E0000h-1E7FFFh |
| | | | SA61 | 111101XXX | 64/32 | 3D0000h-3DFFFFh | 1E8000h-1EFFFFh |
| | | د 1 | SA62 | 111110XXX | 64/32 | 3E0000h-3EFFFFh | 1F0000h-1F7FFFh |
| | | ank | SA63 | 111111000 | 8/4 | 3F0000h-3FFFFFh | 1F8000h-1F8FFFh |
| | | B | SA64 | 111111001 | 8/4 | 3F2000h-3F3FFFh | 1F9000h-1F9FFFh |
| | | | SA65 | 111111010 | 8/4 | 3F4000h-3F5FFFh | 1FA000h-1FAFFFh |
| | | | SA66 | 111111011 | 8/4 | 3F6000h-3F7FFFh | 1FB000h-1FBFFFh |
| | | | SA67 | 11111100 | 8/4 | 3F8000h-3F9FFFh | 1FC000h-1FCFFFh |
| | | | SA68 | 111111101 | 8/4 | 3FA000h-3FBFFFh | 1FD000h-1FDFFFh |
| | | | SA69 | 11111110 | 8/4 | 3FC000h-3FDFFFh | 1FE000h-1FEFFFh |
| | | | SA70 | 111111111 | 8/4 | 3FE000h-3FFFFFh | 1FF000h-1FFFFFh |

The address range is A20: A-1in byte mode ($\overline{BYTE} = VIL$) or A20:A0 in word mode ($\overline{BYTE} = VIH$). The bank address bits are A20-A18 for A29DL322T, A20 and A19 for A29DL323T, and A20 for A29DL324T.



Table 4. Sector Addresses for Bottom Boot Sector Devices

| SA0 00000000 8/4 000000h-001FFFh 000 SA1 000000001 8/4 00200h-003FFFh 001 SA2 000000010 8/4 00400h-005FFFh 002 SA3 00000011 8/4 006000h-007FFFh 003 SA4 000000100 8/4 008000h-009FFFh 003 SA4 000000100 8/4 008000h-009FFFh 003 | 0000h-000FFFh 000h-001FFFh 2000h-002FFFh 3000h-003FFFh 4000h-004FFFh 5000h-005FFFh 5000h-007FFFh 6000h-007FFFh 1000h-017FFFh |
|---|--|
| SA1 00000001 8/4 002000h-003FFFh 001 SA2 00000010 8/4 004000h-005FFFh 002 SA3 000000011 8/4 006000h-007FFFh 003 SA4 000000100 8/4 008000h-009FFFh 003 SA4 000000100 8/4 008000h-009FFFh 003 | 000h-001FFFh 2000h-002FFFh 3000h-003FFFh 4000h-004FFFh 5000h-005FFFh 5000h-006FFFh 7000h-007FFFh 1000h-007FFFh |
| SA2 00000010 8/4 004000h-005FFFh 002 SA3 000000011 8/4 006000h-007FFFh 003 SA4 000000100 8/4 008000h-009FFFh 004 | 2000h-002FFFh 3000h-003FFFh 4000h-004FFFh 5000h-005FFFh 5000h-006FFFh 7000h-007FFFh 1000h-00FFFFh 1000h-017FFFh |
| SA3 00000011 8/4 006000h-007FFFh 003 SA4 000000100 8/4 008000h-009FFFh 004 | 3000h-003FFFh 4000h-004FFFh 5000h-005FFFh 5000h-006FFFh 7000h-007FFFh 1000h-00FFFFh 1000h-017FFFh |
| SA4 000000100 8/4 008000h-009FFFh 004 | 4000h-004FFFh 5000h-005FFFh 5000h-006FFFh 7000h-007FFFh 5000h-007FFFh 1000h-017FFFh |
| | 5000h-005FFFh 5000h-006FFFh 7000h-007FFFh 5000h-00FFFFh 1000h-017FFFh |
| SA5 000000101 8/4 00A000h-00BFFFh 005 | 0000h-006FFFh 7000h-007FFFh 1000h-00FFFFh 1000h-017FFFh |
| <u> </u> | 2000h-007FFFh 3000h-00FFFFh 3000h-017FFFh |
| SA7 000000111 8/4 00E000h-00FFFh 007 | 3000h-00FFFFh)000h-017FFFh |
| m SA8 000001XXX 64/32 010000h-01FFFFh 008 | 0000h-017FFFh |
| SA9 000010XXX 64/32 020000h-02FFFFh 010 | |
| SA10 000011XXX 64/32 030000h-03FFFFh 018 | 000h-01FFFFh |
| E SA11 000100XXX 64/32 040000h-04FFFFh 020 |)000h-027FFFh |
| G SA12 000101XXX 64/32 050000h-05FFFFh 028 | 3000h-02FFFFh |
| SA13 000110XXX 64/32 060000h-06FFFFh 030 | 0000h-037FFFh |
| SA14 000111XXX 64/32 070000h-07FFFh 038 | 3000h-03FFFFh |
| SA15 001000XXX 64/32 080000h-08FFFFh 040 | 0000h-047FFFh |
| SA16 001001XXX 64/32 090000h-09FFFFh 048 | 000h-04FFFh |
| SA17 001010XXX 64/32 0A0000h-0AFFFFh 050 | 0000h-057FFFh |
| SA18 001011XXX 64/32 0B0000h-0BFFFFh 058 N 004400XXX 04/32 0B0000h-0BFFFFh 058 | 0000h-05FFFFh |
| | |
| | |
| SA21 001110XXX 64/32 0E0000h-0EFFFFN 070 | 2000h-077FFFh |
| SA22 001111XXX 04/32 0F000011-0FFFF11 076 | 00001-07FFF11 |
| SA23 010000AAA 04/32 1000001-10FFFF1 080 | 2000h-08FFFFh |
| SA25 010001XXX 64/32 120000-12EEEb 090 | 0000H-007FFFh |
| SA26 010010XXX 64/32 1200001-12FFFb 098 | 0000h-09FFFFh |
| SA27 010100XXX 64/32 140000b-14EEEEb 0A0 | 0000h-0A7FFFh |
| SA28 010101XXX 64/32 150000b-15EEEb 0A8 | 3000h-0AFFFFh |
| SA29 010110XXX 64/32 160000h-16FFFh 0B0 |)000h-0B7FFFh |
| N SA30 010111XXX 64/32 170000h-17FFFh 0B8 | 3000h-0BFFFFh |
| SA31 011000XXX 64/32 180000h-18FFFFh 0C0 | 0000h-0C7FFFh |
| SA32 011001XXX 64/32 190000h-19FFFFh 0C8 | 3000h-0CFFFFh |
| SA33 011010XXX 64/32 1A0000h-1AFFFFh 0D0 | 000h-0D7FFFh |
| SA34 011011XXX 64/32 1B0000h-1BFFFFh 0D8 | 3000h-0DFFFFh |
| SA35 011100XXX 64/32 1C0000h-1CFFFFh 0E0 | 0000h-0E7FFFh |
| m SA36 011101XXX 64/32 1D0000h-1DFFFFh 0E8 | 3000h-0EFFFFh |
| SA37 011110XXX 64/32 1E0000h-1EFFFFh 0F0 | 000h-0F7FFFh |
| SA38 011111XXX 64/32 1F0000h-1FFFFh 0F8 | 3000h-0FFFFFh |
| SA39 100000XXX 64/32 200000h-20FFFh 100 |)000h-107FFFh |
| SA40 100001XXX 64/32 210000h-21FFFFh 108 | 3000h-10FFFFh |
| SA41 100010XXX 64/32 220000h-22FFFFh 110 |)000h-117FFFh |
| SA42 100011XXX 64/32 230000h-23FFFFh 118 | 3000h-11FFFFh |
| SA43 100100XXX 64/32 240000h-24FFFFh 120 SA44 4004000000000000000000000000000000000 | 0000h-127FFFh |
| SA44 100101XXX 64/32 250000h-25FFFFh 128 | |
| SA45 100110XXX 64/32 260000h-26FFFFh 130 | |
| SA40 100111AAA 04/32 2700000-27FFFFn 138 SA47 101000XXX 64/32 280000b-28FFFFb 140 | |



| A29DL324U | A29DL323U | A29DL322U | Sector | Sector Address A20–A12 | Sector Size (Kbytes/Kwords) | (x8) Address Range | (x16) Address Range |
|-----------|-----------|-----------|--------|---------------------------|--------------------------------|-----------------------|------------------------|
| | | | SA48 | 101001XXX | 64/32 | 290000h-29FFFFh | 148000h-14FFFFh |
| | | | SA49 | 101010XXX | 64/32 | 2A0000h-2AFFFFh | 150000h-157FFFh |
| | | | SA50 | 101011XXX | 64/32 | 2B0000h-2BFFFFh | 158000h-15FFFFh |
| | | | SA51 | 101100XXX | 64/32 | 2C0000h-2CFFFFh | 160000h-167FFFh |
| | | | SA52 | 101101XXX | 64/32 | 2D0000h-2DFFFFh | 168000h-16FFFFh |
| | | | SA53 | 101110XXX | 64/32 | 2E0000h-2EFFFFh | 170000h-177FFFh |
| | | | SA54 | 101111XXX | 64/32 | 2F0000h-2FFFFFh | 178000h-17FFFFh |
| | | | SA55 | 110000XXX | 64/32 | 300000h-30FFFFh | 180000h-187FFFh |
| | | | SA56 | 110001XXX | 64/32 | 310000h-31FFFFh | 188000h-18FFFFh |
| | | | SA57 | 110010XXX | 64/32 | 320000h-32FFFFh | 190000h-197FFFh |
| 2 | 2 | 2 | SA58 | 110011XXX | 64/32 | 330000h-33FFFFh | 198000h-19FFFFh |
| ank | ank | ank | SA59 | 110100XXX | 64/32 | 340000h-34FFFFh | 1A0000h-1A7FFFh |
| B | B | B | SA60 | 110101XXX | 64/32 | 350000h-35FFFFh | 1A8000h-1AFFFFh |
| | | | SA61 | 110110XXX | 64/32 | 360000h-36FFFFh | 1B0000h-1B7FFFh |
| | | | SA62 | 110111XXX | 64/32 | 370000h-37FFFFh | 1B8000h-1BFFFFh |
| | | | SA63 | 111000XXX | 64/32 | 380000h-38FFFFh | 1C0000h-1C7FFFh |
| | | | SA64 | 111001XXX | 64/32 | 390000h-39FFFFh | 1C8000h-1CFFFFh |
| | | | SA65 | 111010XXX | 64/32 | 3A0000h-3AFFFFh | 1D0000h-1D7FFFh |
| | | | SA66 | 111011XXX | 64/32 | 3B0000h-3BFFFFh | 1D8000h-1DFFFFh |
| | | | SA67 | 111100XXX | 64/32 | 3C0000h-3CFFFFh | 1E0000h-1E7FFFh |
| | | | SA68 | 111101XXX | 64/32 | 3D0000h-3DFFFFh | 1E8000h-1EFFFFh |
| | | | SA69 | 111110XXX | 64/32 | 3E0000h-3EFFFFh | 1F0000h-1F7FFFh |
| | | | SA70 | 111111XXX | 64/32 | 3F0000h-3FFFFFh | 1F8000h-1FFFFFh |

Note:

The address range is A20: A-1in byte mode ($\overline{BYTE} = VIL$) or A20:A0 in word mode ($\overline{BYTE} = VIH$). The bank address bits are A20-A18 for A29DL322U, A20 and A19 for A29DL323U, and A20 for A29DL324U.



Autoselect Mode

The autoselect mode provides manufacturer and device identification, and sector protection verification, through identifier codes output on $I/O_7 - I/O_0$. This mode is primarily intended for programming equipment to automatically match a device to be programmed with its corresponding programming algorithm. However, the autoselect codes can also be accessed in-system through the command register.

When using programming equipment, the autoselect mode requires V_{ID} (8.5V to 12.5 V) on address pin A9. Address pins A6, A1, and A0 must be as shown in Table 5. In addition, when verifying sector protection, the sector address

must appear on the appropriate highest order address bits. (see Table 3-4). Table 5 shows the remaining address bits that are don't care. When all necessary bits have been set as required, the programming equipment may then read the corresponding identifier code on $I/O_7 - I/O_0$.

To access the autoselect codes in-system, the host system can issue the autoselect command via the command register, as shown in Table 12. This method does not require V_{ID}. Refer to the Autoselect Command Sequence section for more information.

| | | | | A20 | Δ11 | | A 8 | | Α5 | | | | | I/Os to | I/O15 | 1/07 |
|--------------------------|----|----|----|-----------|-----------|-----|------------|----|----------|----|----|----|----|---------------|---------------|---------------------------------------|
| Description | CE | OE | WE | to A12 | to A10 | A9 | to A7 | A6 | to A4 | A3 | A2 | A1 | A0 | BYTE = ViH | BYTE = Vı∟ | to I/Oo |
| Manufacturer ID: AMIC | L | L | Н | BA | Х | Vid | х | L | х | L | L | L | L | Х | х | 37h |
| Device ID: A29DL322 | L | L | н | BA | х | Vid | Х | L | Х | Х | Х | L | Н | 22h | х | 55h (T), 56h (U) |
| Device ID: A29DL323 | L | L | Н | BA | Х | Vid | Х | L | Х | Х | Х | L | Н | 22h | х | 50h (T), 53h (U) |
| Device ID: A29DL324 | L | L | Н | BA | х | Vid | Х | L | Х | Х | Х | L | Н | 22h | х | 5Ch (T), 5Fh (U) |
| Continuation ID | L | L | Н | Х | Х | Vid | х | L | х | х | х | н | н | Х | х | 7Fh |
| Read Sector Status | L | L | Н | SA | х | Vid | х | L | х | L | L | Н | L | х | х | 01h (protected), 00h (unprotected) |

Table 5. A29DL32x Autoselect Codes (High Voltage Method)

L=Logic Low= VIL, H=Logic High=VIH, SA=Sector Address, X=Don't Care, BA=Bank Address

Note: The autoselect codes may also be accessed in-system via command sequences.

AMIC

Sector/Sector Block Protection and Unprotection

(Note: For the following discussion, the term "sector" applies to both sectors and sector blocks. A sector block consists of two or more adjacent sectors that are protected or unprotected at the same time (see Tables 6 and 7).

| Table 6. | Тор | Boot | Sector/Sector | Block | Addresses | for |
|------------|-------|--------|---------------|-------|-----------|-----|
| Protection | ո/Սոլ | protec | tion | | | |

| Sector / Sector Block | A20–A12 | Sector / Sector Block Size |
|--------------------------|---------------------------------------|----------------------------|
| SA0 | 000000XXX | 64 Kbytes |
| SA1-SA3 | 000001XXX, 000010XXX, 000011XXX | 192 (3x64) Kbytes |
| SA4-SA7 | 0001XXXXX | 256 (4x64) Kbytes |
| SA8-SA11 | 0010XXXXX | 256 (4x64) Kbytes |
| SA12-SA15 | 0011XXXXX | 256 (4x64) Kbytes |
| SA16-SA19 | 0100XXXXX | 256 (4x64) Kbytes |
| SA20-SA23 | 0101XXXXX | 256 (4x64) Kbytes |
| SA24-SA27 | 0110XXXXX | 256 (4x64) Kbytes |
| SA28-SA31 | 0111XXXXX | 256 (4x64) Kbytes |
| SA32-SA35 | 1000XXXXX | 256 (4x64) Kbytes |
| SA36-SA39 | 1001XXXXX | 256 (4x64) Kbytes |
| SA40-SA43 | 1010XXXXX | 256 (4x64) Kbytes |
| SA44-SA47 | 1011XXXXX | 256 (4x64) Kbytes |
| SA48-SA51 | 1100XXXXX | 256 (4x64) Kbytes |
| SA52-SA55 | 1101XXXXX | 256 (4x64) Kbytes |
| SA56-SA59 | 1110XXXXX | 256 (4x64) Kbytes |
| SA60-SA62 | 111100XXX, 111101XXX, 111110XXX | 192 (3x64) Kbytes |
| SA63 | 111111000 | 8 Kbytes |
| SA64 | 111111001 | 8 Kbytes |
| SA65 | 111111010 | 8 Kbytes |
| SA66 | 111111011 | 8 Kbytes |
| SA67 | 111111100 | 8 Kbytes |
| SA68 | 111111101 | 8 Kbytes |
| SA69 | 111111110 | 8 Kbytes |
| SA70 | 111111111 | 8 Kbytes |

 Table 7. Bottom Boot Sector/Sector Block Addresses for

 Protection/Unprotection

| Sector / Sector Block | A20–A12 | Sector / Sector Block Size |
|--------------------------|---------------------------------------|----------------------------|
| SA70 | 111111XXXX | 64 Kbytes |
| SA69- SA67 | 111110XXX, 111101XXX, 111100XXX | 192 (3x64) Kbytes |
| SA66- SA63 | 1110XXXXX | 256 (4x64) Kbytes |
| SA62- SA59 | 1101XXXXX | 256 (4x64) Kbytes |
| SA58- SA55 | 1100XXXXX | 256 (4x64) Kbytes |
| SA54- SA51 | 1011XXXXX | 256 (4x64) Kbytes |
| SA50- SA47 | 1010XXXXX | 256 (4x64) Kbytes |
| SA46-SA43 | 1001XXXXX | 256 (4x64) Kbytes |
| SA42-SA39 | 1000XXXXX | 256 (4x64) Kbytes |
| SA38-SA35 | 0111XXXXX | 256 (4x64) Kbytes |
| SA34-SA31 | 0110XXXXX | 256 (4x64) Kbytes |
| SA30-SA27 | 0101XXXXX | 256 (4x64) Kbytes |
| SA26-SA23 | 0100XXXXX | 256 (4x64) Kbytes |
| SA22-SA19 | 0011XXXXX | 256 (4x64) Kbytes |
| SA18-SA15 | 0010XXXXX | 256 (4x64) Kbytes |
| SA14-SA11 | 0001XXXXX | 256 (4x64) Kbytes |
| SA10-SA8 | 000001XXX, 000010XXX, 000011XXX | 192 (3x64) Kbytes |
| SA7 | 000000111 | 8 Kbytes |
| SA6 | 000000110 | 8 Kbytes |
| SA5 | 000000101 | 8 Kbytes |
| SA4 | 000000100 | 8 Kbytes |
| SA3 | 000000011 | 8 Kbytes |
| SA2 | 00000010 | 8 Kbytes |
| SA1 | 00000001 | 8 Kbytes |
| SA0 | 00000000 | 8 Kbytes |





The hardware sector protection feature disables both program and erase operations in any sector. The hardware sector unprotection feature re-enables both program and erase operations in previously protected sectors. Sector protection and unprotection can be implemented via two methods.

The primary method requires V_{ID} on the RESET pin only, and can be implemented either in-system or via programming equipment. Figure 2 shows the algorithms and Figure 23 shows the timing diagram. This method uses standard microprocessor bus cycle timing. For sector unprotect, all unprotected sectors must first be protected prior to the first sector unprotect write cycle.

The sector unprotect algorithm unprotects all sectors in parallel. All previously protected sectors must be individually re-protected. To change data in protected sectors efficiently, the temporary sector unprotect function is available. See "Temporary Sector/Sector Block Unprotect".

The alternate method for protection and unprotection is by software sector /sector block protect unprotect command. See Figure 2 for Command Flow.

The device is shipped with all sectors unprotected.

It is possible to determine whether a sector is protected or unprotected. See the Autoselect Mode section for details.

Write Protect (WP)

The Write Protect function provides a hardware method of protecting certain boot sectors without using V_{ID}. This function is one of two provided by the \overline{WP} /ACC pin.

If the system asserts VIL on the WP /ACC pin, the device disables program and erase functions in the two "outermost" 8 Kbyte boot sectors independently of whether those sectors were protected or unprotected using the method described in

"Sector/Sector Block Protection and Unprotection". The two outermost 8 Kbyte boot sectors are the two sectors containing the lowest addresses in a bottom-boot-configured device, or the two sectors containing the highest addresses in a top-boot-configured device.

If the system asserts VIH on the $\overline{\text{WP}}$ /ACC pin, the device reverts to whether the two outermost 8 Kbyte boot sectors were last set to be protected or unprotected. That is, sector protection or unprotection for these two sectors depends on whether they were last protected or unprotected using the method described in "Sector/Sector Block Protection and Unprotection".

Note that the \overline{WP} /ACC pin must not be left floating or unconnected; inconsistent behavior of the device may result.

Temporary Sector/Sector Block Unprotect

(Note: For the following discussion, the term "sector" applies to both sectors and sector blocks. A sector block consists of two or more adjacent sectors that are protected or unprotected at the same time (see Tables 6 and 7).

This feature allows temporary unprotection of previously protected sectors to change data in-system. The Sector Unprotect mode is activated by setting the RESET pin to Vib (8.5V-12.5V). During this mode, formerly protected sectors can be programmed or erased by selecting the sector addresses. Once Vib is removed from the RESET pin, all the previously protected sectors are protected again. Figure 1 shows the algorithm, and Figure 22 shows the timing diagrams, for this feature.



A29DL32x Series



Notes:

- 1. All protected sectors unprotected (If $\overline{\text{WP}}/\text{ACC}{=}\text{ViL},$
- outermost boot sectors will remain protected). 2. All previously protected sectors are protected once again.

Figure 1-1. Temporary Sector Unprotect Operation by RESET Mode

Figure 1-2. Temporary Sector Unprotect Operation by Software Mode



Figure 2-1. High Voltage Sector/Sector Block Protection and Unprotection Algorithms



Note: The term "sector" in the figure applies to both sectors and sector blocks

* No other command is allowed during this process

** Read access time is 200ns-300ns

Figure 2-2. Software Sector/Sector Block Protection and Unprotection Algorithms



Hardware Data Protection

The command sequence requirement of unlock cycles for programming or erasing provides data protection against inadvertent writes (refer to Table 12 for command definitions). In addition, the following hardware data protection measures prevent accidental erasure or programming, which might otherwise be caused by spurious system level signals during VCC power-up and power-down transitions, or from system noise.

Low VCC Write Inhibit

When VCC is less than VLKO, the device does not accept any write cycles. This protects data during VCC power-up and power-down. The command register and all internal program/erase circuits are disabled, and the device resets to reading array data. Subsequent writes are ignored until VCC is greater than VLKO. The system must provide the proper signals to the control pins to prevent unintentional writes when VCC is greater than VLKO.

Write Pulse "Glitch" Protection

Noise pulses of less than 5ns (typical) on \overline{OE} , \overline{CE} or \overline{WE} do not initiate a write cycle.

Logical Inhibit

Write cycles are inhibited by holding any one of $\overline{OE} = V_{IL}$, $\overline{CE} = V_{IH}$ or $\overline{WE} = V_{IH}$. To initiate a write cycle, \overline{CE} and \overline{WE} must be a logical zero while \overline{OE} is a logical one.

Power-Up Write Inhibit

If $\overline{WE} = \overline{CE} = V_{IL}$ and $\overline{OE} = V_{IH}$ during power up, the device does not accept commands on the rising edge of \overline{WE} . The internal state machine is automatically reset to reading array data on power-up.

COMMON FLASH MEMORY INTERFACE (CFI)

The Common Flash Interface (CFI) specification outlines device and host system software interrogation handshake, which allows specific vendor-specified software algorithms to be used for entire families of devices. Software support can then be device-independent, JEDEC ID-independent, and forward- and backward-compatible for the specified flash device families. Flash vendors can standardize their existing interfaces for long-term compatibility.

This device enters the CFI Query mode when the system writes the CFI Query command, 98h, to address 55h in word mode (or address AAh in byte mode), any time the device is ready to read array data. The system can read CFI information at the addresses given in Tables 8-11. To terminate reading CFI data, the system must write the reset command.

The system can also write the CFI query command when the device is in the autoselect mode. The device enters the CFI query mode, and the system can read CFI data at the addresses given in Tables 8-11. The system must write the reset command to return the device to the autoselect mode.

| Addresses (Word Mode) | Addresses (Byte Mode) | Data | Description | | | | | |
|--------------------------|--------------------------|-------|--|--|--|--|--|--|
| 10h | 20h | 0051h | | | | | | |
| 11h | 22h | 0052h | Query Unique ASCII string "QRY" | | | | | |
| 12h | 24h | 0059h | | | | | | |
| 13h | 26h | 0002h | Primary OFM Command Set | | | | | |
| 14h | 28h | 0000h | | | | | | |
| 15h | 2Ah | 0040h | Address for Primary Extended Table | | | | | |
| 16h | 2Ch | 0000h | | | | | | |
| 17h | 2Eh | 0000h | Alternate OEM Command Set (00b - pope exists) | | | | | |
| 18h | 30h | 0000h | | | | | | |
| 19h | 32h | 0000h | Address for Alternate OEM Extended Table (00b - none exists) | | | | | |
| 1Ah | 34h | 0000h | Address for Alternate OLINI Externate Table (0011 = 110118 exists) | | | | | |

Table 8. CFI Query Identification String

Table 9. System Interface String

| Addresses (Word Mode) | Addresses (Byte Mode) | Data | Description | | | | |
|--------------------------|--------------------------|-------|--|--|--|--|--|
| 1Bh | 36h | 0027h | VCC Min. (write/erase) | | | | |
| | | | I⁄O7- I∕O₄: volt, I/O3- I/Oα 100 millivolt | | | | |
| 1Ch | 38h | 0036h | VCC Max. (write/erase) | | | | |
| | | | VO7- VO4: volt, I/O3- VOx 100 millivolt | | | | |
| 1Dh | 3Ah | 0000h | Vpp Min. voltage (00h = no Vpp pin present) | | | | |
| 1Eh | 3Ch | 0000h | Vpp Max. voltage (00h = no Vpp pin present) | | | | |
| 1Fh | 3Eh | 0003h | Typical timeout per single byte/word write 2 ^N μs | | | | |
| 20h | 40h | 0000h | Typical timeout for Min. size buffer write $2^{N} \mu s$ (00h = not supported) | | | | |
| 21h | 42h | 0009h | Typical timeout per individual block erase 2 ^N ms | | | | |
| 22h | 44h | 0000h | Typical timeout for full chip erase 2^{N} ms (00h = not supported) | | | | |
| 23h | 46h | 0005h | Max. timeout for byte/word write 2 ^N times typical | | | | |
| 24h | 48h | 0000h | Max. timeout for buffer write 2 ^N times typical | | | | |
| 25h | 4Ah | 0004h | Max. timeout per individual block erase 2 ^N times typical | | | | |
| 26h | 4Ch | 0000h | Max. timeout for full chip erase 2^{N} times typical (00h = not supported) | | | | |

Table 10 Device Geometry Definition

| Addresses | Addresses | D. (| |
|-------------|-------------|-------|---|
| (Word Mode) | (Byte Mode) | Data | Description |
| 27h | 4Eh | 0016h | Device Size = 2^{N} byte |
| 28h | 50h | 0002h | Elash Device Interface description |
| 29h | 52h | 0000h | |
| 2Ah | 54h | 0000h | Max. number of byte in multi-byte write = 2^{N} |
| 2Bh | 56h | 0000h | (00h = not supported) |
| 2Ch | 58h | 0002h | Number of Erase Block Regions within device |
| 2Dh | 5Ah | 0007h | |
| 2Eh | 5Ch | 0000h | Erase Block Region 1 Information |
| 2Fh | 5Eh | 0020h | (refer to the CFT specification) |
| 30h | 60h | 0000h | |
| 31h | 62h | 003Eh | |
| 32h | 64h | 0000h | Erase Block Region 2 Information |
| 33h | 66h | 0000h | |
| 34h | 68h | 0001h | |
| 35h | 6Ah | 0000h | |
| 36h | 6Ch | 0000h | Erase Block Region 3 Information |
| 37h | 6Eh | 0000h | |
| 38h | 70h | 0000h | |
| 39h | 72h | 0000h | |
| 3Ah | 74h | 0000h | Erase Block Region 4 Information |
| 3Bh | 76h | 0000h | |
| 3Ch | 78h | 0000h | |



Table 11. Primary Vendor-Specific Extended Query

| Addresses (Word Mode) | Addresses (Byte Mode) | Data | Description |
|--------------------------|--------------------------|---------|---|
| 40h | 80h | 0050h | Query-unique ASCII string "PRI" |
| 41h | 82h | 0052h | |
| 42h | 84h | 0049h | |
| 43h | 86h | 0031h | Major version number, ASCII |
| 44h | 88h | 0033h | Minor version number, ASCI |
| 45h | 8Ah | 0000h | Address Sensitive Unlock |
| | | | 0 = Required, 1 = Not Required |
| 46h | 8Ch | 0002h | Erase Suspend |
| | | | 0 = Not Supported, 1 = To Read Only, 2 = To Read & Write |
| 47h | 8Eh | 0001h | Sector Protect |
| | | | 0 = Not Supported, X = Number of sectors in per group |
| 48h | 90h | 0001h | Sector Temporary Unprotect |
| | | | 00 = Not Supported, 01 = Supported |
| 49h | 92h | 0004h | Sector Protect/Unprotect scheme |
| | | | 04 = A29L800 mode |
| 4Ah | 94h | 00XXh | Number of Sectors (Excluding Bank 1) |
| | | | XX = 38 (A29DL322) |
| | | | XX = 30 (A29DL323) |
| | | | XX = 20 (A29DL324) |
| 4Bh | 96h | 0000h | Burst Mode Type |
| | | | 00 = Not Supported, 01 = Supported |
| 4Ch | 98h | 0000h | Page Mode Type |
| | | | 00 = Not Supported, 01 = 4 Word Page, 02 = 8 Word Page |
| | QAb | 0085h | ACC (Acceleration) Supply Minimum 00h = Not Supported, D7-D4: Volt, |
| 4011 | 9A11 | 000511 | D3-D0: 100 mV |
| 4Eh | 9Ch | 0095h | ACC (Acceleration) Supply Maximum 00h = Not Supported, D7-D4: Volt, D3-D0: 100 mV |
| 4Fh | 9Eh | 000Xh | Top/Bottom Boot Sector Flag 02h = Bottom Boot Device, 03h = Top Boot Device |
| 50b | AOb | 0000h | Program Suspend |
| 5011 | Aun | 000011 | 0 = Not Supported, 1 = Supported |
| 57h | ۸Eb | 00026 | Bank Organization |
| 5/11 | , (Ell | 000211 | X = 2 (2 banks, all models) |
| | | | Bank 1 Region Information – Number of Sectors on Bank 1 |
| 58h | B0b | 00XXh | XX = 0F (A29DL322) |
| 0011 | Don | 007041 | XX = 17 (A29DL323) |
| | | | XX = 27 (A29DL324) |
| | | | Bank 2 Region Information – Number of Sectors in Bank 2 |
| 59h | B2h | 00XXh | XX = 38 (A29DL322) |
| 0011 | DZII | 0077711 | XX = 30 (A29DL323) |
| | | | XX = 20 (A29DL324) |
| 5Ah | B4h | 0000 | Bank 3 Region Information – Number of Sector in Bank 3 |
| 5Bh | B6h | 0000 | Bank 4 Region Information – Number of Sector in Bank 4 |

ΔΜΙC

COMMAND DEFINITIONS

Writing specific address and data commands or sequences into the command register initiates device operations. Table 12 defines the valid register command sequences. Writing incorrect address and data values or writing them in the improper sequence may place the device in an unknown state. A reset command is then required to return the device to reading array data.

All addresses are latched on the falling edge of $\overline{\mathsf{WE}}$ or $\overline{\mathsf{CE}}$, whichever happens later. All data is latched on the rising edge of $\overline{\mathsf{WE}}$ or $\overline{\mathsf{CE}}$, whichever happens first. Refer to the AC Characteristics section for timing diagrams.

Reading Array Data

The device is automatically set to reading array data after device power-up. No commands are required to retrieve data. The device is also ready to read array data after completing an Embedded Program or Embedded Erase algorithm.

After the device accepts an Erase Suspend command, the corresponding bank enters the erase-suspend-read mode, after which the system can read data from any non-erase-suspended sector within the same bank. After completing a programming operation in the Erase Suspend mode, the system may once again read array data with the same exception. See the Erase Suspend/Erase Resume Commands section for more information.

The system must issue the reset command to return a bank to the read (or erase-suspend-read) mode if I/O_5 goes high during an active program or erase operation, or if the bank is in the autoselect mode. See the next section, Reset Command, for more information.

See also Requirements for Reading Array Data in the Device Bus Operations section for more information. The Read-Only Operations table provides the read parameters, and Figure 11 shows the timing diagram.

Reset Command

Writing the reset command resets the banks to the read or erase-suspend-read mode. Address bits are don't cares for this command.

The reset command may be written between the sequence cycles in an erase command sequence before erasing begins. This resets the bank to which the system was writing to reading array data. Once erasure begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in a program command sequence before programming begins. This resets the bank to which the system was writing to reading array data. If the program command sequence is written to a bank that is in the Erase Suspend mode, writing the reset command returns that bank to the erase-suspend-read mode. Once programming begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in an autoselect command sequence. Once in the autoselect mode, the reset command must be written to return to reading array data. If a bank entered the autoselect mode while in the Erase Suspend mode, writing the reset command returns that bank to the erase-suspend-read mode. If I/O₅ goes high during a program or erase operation, writing the reset command returns the banks to reading array data

(or erase-suspend-read mode if that bank was in Erase Suspend).

Autoselect Command Sequence

The autoselect command sequence allows the host system to access the manufacturer and device codes, and determine whether or not a sector is protected. Table 12 shows the address and data requirements. This method is an alternative to that shown in Table 5, which is intended for PROM programmers and requires VID on address pin A9. The autoselect command sequence may be written to an address wit h in a bank that is either in t he read or erase-suspend-read mode. The autoselect command may not be written while the device is actively programming or erasing in the other bank.

The autoselect command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle that contains the bank address and the autoselect command. T he bank then enter s the autoselect mode. The system may read at any address within the same bank any number of times without initiating another autoselect command sequence:

- A read cycle at address (BA)XX00h (where BA is the bank address) returns the manufacturer code.
- A read cycle at address (BA)XX01h in word mode (or (BA)XX02h in byte mode) returns the device code.
- A read cycle to an address containing a sector address (SA) within the same bank, and the address 02h on A7-A0 in word mode (or the address 04h on A6-A-1 in byte mode) returns 01h if the sector is protected, or 00h if it is unprotected. (Refer to Tables 3-4 for valid sector addresses).

The system must write the reset command to return to reading array data (or erase-suspend-read mode if the bank was previously in Erase Suspend).

Byte/Word Program Command Sequence

The system may program the device by word or byte, depending on the state of the BYTE pin. Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two unlock write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded Program algorithm. The system is not required to provide further controls or timings. The device automatically provides internally generated program pulses and verifies the programmed cell margin. Table 12 shows the address and data requirements for the byte program command sequence. When the Embedded Program algorithm is complete, that bank then returns to reading array data and addresses are no longer latched. The system can determine the status of

the program operation by using I/O7, I/O6, or RY/\overline{BY} . Refer to the Write Operation Status section for information on these status bits.

Any commands written to the device during the Embedded Program Algorithm are ignored. Note that a hardware reset immediately terminates the program operation. The program command sequence should be reinitiated once that bank has returned to reading array data, to ensure data integrity.

Programming is allowed in any sequence and across sector boundaries. A bit cannot be programmed from "0" back to a "1." Attempting to do so may cause that bank to set $I/O_5 = 1$, or cause the I/O_7 and I/O_6 status bits to indicate the operation was successful. However, a succeeding read will show that the data is still "0." Only erase operations can convert a "0" to a "1."



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Unlock Bypass Command Sequence

The unlock bypass feature allows the system to program bytes or words to a bank faster than using the standard program command sequence. The unlock bypass command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle containing the unlock bypass command, 20h. The device then enters the unlock bypass mode. A two-cycle unlock bypass program command sequence is all that is required to program in this mode. The first cycle in this sequence contains the unlock bypass program command, A0h; the second cycle contains the program address and data. Additional data is programmed in the same manner. This mode dispenses with the initial two unlock cycles required in the standard program command sequence, resulting in faster total programming time. Table 12 shows the requirements for the command sequence.

During the unlock bypass mode, only the Unlock Bypass Program and Unlock Bypass Reset commands are valid. To exit the unlock bypass mode, the system must issue the twocycle unlock bypass reset command sequence. The device then returns to reading array data.

The device offers accelerated program operations through the \overline{WP} /ACC pin. When the system asserts V_{HH} on the \overline{WP} /ACC pin, the device automatically enters the Unlock Bypass mode. The system may then write the two-cycle Unlock Bypass program command sequence. The device uses the higher voltage on the \overline{WP} /ACC pin to accelerate the operation. Note that the \overline{WP} /ACC pin must not be at V_{HH} any operation other than accelerated programming, or device damage may result. In addition, the \overline{WP} /ACC pin must not be left floating or unconnected; inconsistent behavior of the device may result.

Figure 3 illustrates the algorithm for the program operation. Refer to the Erase and Program Operations table in the AC Characteristics section for parameters, and Figure 15 for timing diagrams.



Note : See Table 14 for program command sequnce.

Figure 3. Program Operation



Chip Erase Command Sequence

Chip erase is a six bus cycle operation. The chip erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the chip erase command, which in turn invokes the Embedded Erase algorithm. The device does not require the system to preprogram prior to erase. The Embedded Erase algorithm automatically preprograms and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations. Table 12 shows the address and data requirements for the chip erase command sequence.

When the Embedded Erase algorithm is complete, that bank returns to reading array data and addresses are no longer latched. The system can determine the status of the erase

operation by using I/O₇, I/O₆, I/O₂, or RY/ $\overline{\text{BY}}$. Refer to the Write Operation Status section for information on these status bits.

Any commands written during the chip erase operation are ignored. However, note that a hardware reset immediately terminates the erase operation. If that occurs, the chip erase command sequence should be reinitiated once that bank has returned to reading array data, to ensure data integrity.

Figure 4 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Figure 17 section for timing diagrams.

Sector Erase Command Sequence

Sector erase is a six bus cycle operation. The sector erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock cycles are written, and are then followed by the address of the sector to be erased, and the sector erase command. Table 12 shows the address and data requirements for the sector erase command sequence.

The device does not require the system to preprogram prior to erase. The Embedded Erase algorithm automatically programs and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations.

After the command sequence is written, a sector erase timeout of 50 µs occurs. During the time-out period, additional sector addresses and sector erase commands within the bank may be written. Loading the sector erase buffer may be done in any sequence, and the number of sectors may be from one sector to all sectors. The time between these additional cycles must be less than 50µs, otherwise erasure may begin. Any sector erase address and command following the exceeded time-out may or may not be accepted. It is recommended that processor interrupts be disabled during this time to ensure all commands are accepted. The interrupts can be re-enabled after the last Sector Erase command is written. Any command other than Sector Erase or Erase Suspend during the time-out period resets that bank to reading array data. The system must rewrite the command sequence and any additional addresses and commands.

The system can monitor I/O₃ to determine if the sector erase timer has timed out (See the section on I/O₃: Sector Erase Timer.). The time-out begins from the rising edge of the final $\overline{\text{WE}}$ pulse in the command sequence.

When the Embedded Erase algorithm is complete, the bank returns to reading array data and addresses are no longer latched. Note that while the Embedded Erase operation is in progress, the system can read data from the non-erasing bank. The system can determine the status of the erase operation by reading I/O_7 , I/O_6 , I/O_2 , or RY/\overline{BY} in the erasing bank.

Refer to the Write Operation Status section for information on these status bits.

Once the sector erase operation has begun, only the Erase Suspend command is valid. All other commands are ignored. However, note that a hardware reset immediately terminates the erase operation. If that occurs, the sector erase command sequence should be reinitiated once that bank has returned to reading array data, to ensure data integrity.

Figure 4 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Figure 17 section for timing diagrams

Erase Suspend/Erase Resume Commands

The Erase Suspend command, B0h, allows the system to interrupt a sector erase operation and then read data from, or program data to, any sector not selected for erasure. This command is valid only during the sector erase operation, including the 50 µs time-out period during the sector erase command sequence. The Erase Suspend command is ignored if written during the chip erase operation or Embedded Program algorithm.

When the Erase Suspend command is written during the sector erase operation, the device requires a maximum of 20 µs to suspend the erase operation. However, when the Erase Suspend command is written during the sector erase time-out, the device immediately terminates the time-out period and suspends the erase operation.

After the erase operation has been suspended, the bank enters the erase-suspend-read mode. The system can read data from or program data to any sector not selected for erasure. (The device "erase suspends" all sectors selected for erasure.) Reading at any address within erase-suspended sectors produces status information on I/O_7 – I/O_0 . The system can use I/O_7 , or I/O_6 and I/O_2 together, to determine if a sector is actively erasing or is erase-suspended. Refer to the Write Operation Status section for information on these status bits.

After an erase-suspended program operation is complete, the bank returns to the erase-suspend-read mode. The system can determine the status of the program operation using the I/O_7 or I/O_6 status bits, just as in the standard Byte Program operation. Refer to the Write Operation Status section for more information.

In the erase-suspend-read mode, the system can also issue the autoselect command sequence. Refer to the Autoselect Mode and Autoselect Command Sequence sections for details.

To resume the sector erase operation, the system must write the Erase Resume command. The bank address of the erase-suspended bank is ignored when writing this command. Further writes of the Resume command are ignored. Another Erase Suspend command can be written after the chip has resumed erasing.





Note :

- 1. See Table 14 for erase command sequence.
- 2. See the section on I/O3 for information on the sector erase timer.

Figure 4. Erase Operation



Command Definitions

Table 12. A29DL32x Command Definitions

| Command | | | | Bus Cycles (Notes 2–5) | | | | | | | | | | |
|-------------------------|---|--|---|---|---|--|---|----------------------|--|----------------------|--|--|--|--|
| Sequence | | ycle | Fir | st | Sec | ond | Thire | d | Fou | rth | Fifth | | Six | th |
| (Note 1) | | Ö | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data |
| Read (Note 6) | | 1 | RA | RD | | | | | | | | | | |
| eset (Note 7) | | 1 | XXX | F0 | | | | | | | | | | |
| Manufacturer ID | Word | Δ | 555 | ΔΔ | 2AA | 55 | (BA)555 | 90 | (BA)X00 | 37 | | | | |
| | Byte | - | AAA | 77 | 555 | 55 | (BA)AAA | 50 | | 57 | | | | |
| Dovico ID | Word | 4 | 555 | ~ ~ | 2AA | 55 | (BA)555 | 00 | (BA)X01 | (see | | | | |
| | Byte | 4 | AAA | AA | 555 | 55 | (BA)AAA | 90 | (BA)X02 | Table5) | | | | |
| | Word | 1 | 555 | ۵۵ | 2AA | 55 | 555 | 90 | X03 | 7E | | | | |
| Continuation ID | Byte | 4 | AAA | ~~ | 555 | 55 | AAA | 30 | X06 | | | | | |
| Sector Protect Verify | Word | 4 | 555 | ~ ~ | 2AA | 55 | (BA)555 | 00 | (SA) | 00/01 | | | | |
| (Note 9) | Byte | 4 | AAA | ~~ | 555 | 55 | (BA)AAA | 50 | (SA)X04 | 00/01 | | | | |
| Command Temporary Word | | 2 | 555 | ~ ~ | 2AA | 55 | 555 | 77 | | | | | | |
| ctor Unprotect (Note15) | Byte | 5 | AAA | AAA | 555 | 55 | AAA | | | | | | | |
| aram | Word | 4 | 555 | - AA - | 2AA | 55 | 555 AAA | A 0 | PΔ | חם | | | | |
| gram | Byte | 4 | AAA | | 555 | 55 | | AU | FA | | | | | |
| look Bypaga | Word | 2 | 555 | 555 , 2 | 2AA | 55 | 555 | 20 | | | | | | |
| IUCK Dypass | Byte | 3 | AAA | AA | 555 | 55 | AAA | 20 | | | | | | |
| lock Bypass Program (No | ote 10) | 2 | XXX | A0 | PA | PD | | | | | | | | |
| ock Bypass Reset (Note | 11) | 2 | XXX | 90 | XXX | 00 | | | | | | | | |
| | Word | 6 | 555 | <u>م</u> م | 2AA | 55 | 555 | 00 | 555 | <u>م</u> م | 2AA | 55 | 555 | 10 |
| ip Liase | Byte | 0 | AAA | ~~ | 555 | 55 | AAA | 80 | AA A | ~~ | 555 | 55 | AAA | 10 |
| ator Eraco | Word | 6 | 555 | <u>م</u> م | 2AA | 55 | 555 | 80 | 555 | <u>م</u> م | 2AA | 55 | 64 | 20 |
| Sector Erase | | 0 | AAA | AA | 555 | | AAA | | AAA | AA | 555 | 55 | SA | 30 |
| Erase Suspend (Note 12) | | 1 | XXX | B0 | | | | | | | | | | |
| ase Resume (Note 13) | | 1 | XXX | 30 | | | | | | | | | | |
| I Query (Note 14) | Word Byte | 1 | 55 AA | 98 | | | | | | | | | | |
| | Sequence (Note 1) ad (Note 6) set (Note 7) Manufacturer ID Device ID Continuation ID Sector Protect Verify (Note 9) mmand Temporary ctor Unprotect (Note15) ogram lock Bypass ock Bypass Program (Note ock Bypass Reset (Note p Erase ctor Erase se Suspend (Note 12) use Resume (Note 13) Query (Note 14) | Sequence (Note 1)ad (Note 6)set (Note 7)Manufacturer IDWordByteDevice IDWordByteContinuation IDWordSector Protect Verify (Note 9)WordBytemmand Temporary ctor Unprotect (Note15)WordByteock Bypass Program (Note 10)Byteock Bypass Reset (Note 11)Wordp EraseWordByteWordctor EraseWordByteWordQuery (Note 14)WordQuery (Note 14)WordByteWordSector Protect Verify (Note 12)WordByteWordByteWordByteWordMordByteWordByteWordByteWordByteWordByte | Sequence (Note 1) $\overline{\begin{subarray}{ll}{ll}}$ ad (Note 6)1set (Note 7)1Manufacturer IDWord Byte4Device IDWord Byte4Continuation IDWord Byte4Sector Protect Verify (Note 9)Word Byte4Sector Protect (Note15)Word Byte3ad mmand Temporary ctor Unprotect 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Legend:

X = Don't care

RA = Address of the memory location to be read.

RD = Data read from location RA during read operation.

- PA = Address of the memory location to be programmed. Addresses latch on the falling edge of the WE or CE pulse, whichever happens later.
- PD = Data to be programmed at location PA. Data latches on the rising edge of \overline{WE} or \overline{CE} pulse, whichever happens first.

SA = Address of the sector to be verified (in autoselect mode) or erased. Address bits A20 - A12 select a unique sector.

BA = Address of the bank that is being switched to autoselect mode, is in bypass mode, or is being erased.

Note:

- 1. See Table 1 for description of bus operations.
- 2. All values are in hexadecimal.
- 3. Except for the read cycle and the fourth cycle of the autoselect command sequence, all bus cycles are write cycles.
- 4. Data bits I/O15-I/O8 are don't care in command sequences. Except for RD and PD.
- 5. Unless otherwise noted, address bits A20-A11 are don't cares.
- 6. No unlock or command cycles required when bank is reading array data.
- 7. The Reset command is required to return to reading array data (or to the erase-suspend-read mode if previously in Erase Suspend) when a bank is in the autoselect mode, or if I/O₅ goes high (while the bank is providing status information).
- The fourth cycle of the autoselect command sequence is a read cycle. The system must provide the bank address to obtain the manufacture ID, or device ID information. Data bits I/O15-I/O8 are don't care. See the Autoselect Command Sequence section for more information.
- 9. The data is 00h for an unprotected sector/sector block and 01h for a protected sector/sector block.
- 10. The Unlock Bypass command is required prior to the Unlock Bypass Program Command.
- The Unlock Bypass Reset command is required to return to reading array data when the bank is in the unlock bypass mode.
 The system may read and program in non-erasing sectors, or enter the autoselect mode, when in the Erase Suspend mode.
- The Erase Suspend command is valid only during a sector erase operation, and require the bank address.
- 13. The Erase Resume command is valid only during the Erase.
- 14. Command is valid when device is ready to read array data or when device is in autoselect mode.
- 15. Once a reset command is applied, software temporary unprotect is exit to return to read array data. But under erase suspend condition, this command is still effective even a reset command has been applied. The reset command which can deactivate the software temporary unprotect command is useful only after the erase command is complete.



WRITE OPERATION STATUS

The device provides several bits to determine the status of a program or erase operation: I/O_2 , I/O_3 , I/O_5 , I/O_6 , and I/O_7 . Table 13 and the following subsections describe the function of these bits. I/O_7 and I/O_6 each offer a method for determining whether a program or erase operation is complete or in progress. The device also provides a hardware-based output signal, RY/\overline{BY} , to determine whether an Embedded Program or Erase operation is in progress or has been completed.

I/O7: Data Polling

The Data Polling bit, I/O_7 , indicates to the host system whether an Embedded Algorithm is in progress or completed, or whether the device is in Erase Suspend. Data Polling is valid after the rising edge of the final \overline{WE} pulse in the program or erase command sequence.

During the Embedded Program algorithm, the device outputs on I/O₇ the complement of the datum programmed to I/O₇. This I/O₇ status also applies to programming during Erase Suspend. When the Embedded Program algorithm is complete, the device outputs the datum programmed to I/O₇. The system must provide the program address to read valid status information on I/O₇. If a program address falls within a protected sector, Data Polling on I/O₇ is active for approximately 1µs, then the device returns to reading array data.

During the Embedded Erase algorithm, Data Polling produces a "0" on I/O7. When the Embedded Erase algorithm is complete, or if the device enters the Erase Suspend mode, Data Polling produces a "1" on I/O7. The system must provide an address within any of the sectors selected for erasure to read valid status information on I/O7.

After an erase command sequence is written, if all sectors selected for erasing are protected, Data Polling on I/O₇ is active for approximately 100 μ s, then the bank returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected. However, if the system reads I/O₇ at an address within a protected sector, the status may not be valid.

Just prior to the completion of an Embedded Program or Erase operation, I/O₇ may change asynchronously with I/O₀–I/O₆ while Output Enable (\overline{OE}) is asserted low. That is, the device may change from providing status information to valid data on I/O₇. Depending on when the system samples the I/O₇ output, it may read the status or valid data. Even if the device has completed the program or erase operation and I/O7 has valid data, the data outputs on I/O₀-I/O₆ may be still invalid. Valid data on I/O₀-I/O₇ will appear on successive read cycles.

Table 13 shows the outputs for $\overline{\text{Data}}$ Polling on I/O7. Figure

5 shows the Data Polling algorithm. Figure 19 in the AC Characteristics section shows the Data Polling timing diagram.



Note :

- VA = Valid address for programming. During a sector erase operation, a valid address is an address within any sector selected for erasure. During chip erase, a valid address is any non-protected sector address.
- 2. I/O7 should be rechecked even if I/Os = "1" because I/O7 may change simultaneously with I/Os.

Figure 5. Data Polling Algorithm

A29DL32x Series





RY/BY : Read/Busy

The RY/ \overline{BY} is a dedicated, open-drain output pin that indicates whether an Embedded algorithm is in progress or complete. The RY/ \overline{BY} status is valid after the rising edge of the final \overline{WE} pulse in the command sequence. Since RY/ \overline{BY}

is an open-drain output, several RY/\overline{BY} pins can be tied together in parallel with a pull-up resistor to VCC.

If the output is low (Busy), the device is actively erasing or programming. (This includes programming in the Erase Suspend mode.) If the output is high (Ready), the device is ready to read array data (including during the Erase Suspend mode), or is in the standby mode.

Table 13 shows the outputs for RY/\overline{BY} .

I/O6: Toggle Bit I

Toggle Bit I on I/O_6 indicates whether an Embedded Program or Erase algorithm is in progress or complete, or whether the device has entered the Erase Suspend mode. Toggle Bit I may be read at any address, and is valid after the rising edge

of the final WE pulse in the command sequence (prior to the program or erase operation), and during the sector erase time-out.

During an Embedded Program or Erase algorithm operation, successive read cycles to any address cause I/O_6 to toggle. The system may use either \overline{OE} or \overline{CE} to control the read

cycles. When the operation is complete, I/O6 stops toggling.

After an erase command sequence is written, if all sectors selected for erasing are protected, I/O_6 toggles for approximately 100µs, then returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

The system can use I/O_6 and I/O_2 together to determine whether a sector is actively erasing or is erase-suspended. When the device is actively erasing (that is, the Embedded Erase algorithm is in progress), I/O_6 toggles. When the device enters the Erase Suspend mode, I/O_6 stops toggling. However, the system must also use I/O_2 to determine which sectors are erasing or erase-suspended. Alternatively, the system can use I/O_7 (see the subsection on " I/O_7 : Data Polling").

If a program address falls within a protected sector, I/O_6 toggles for approximately $1\mu s$ after the program command sequence is written, then returns to reading array data.

I/O₆ also toggles during the erase-suspend-program mode, and stops toggling once the Embedded Program algorithm is complete.

Table 13 shows the outputs for Toggle Bit I on I/O_6 . Figure 6 shows the toggle bit algorithm. Figure 20 in the "AC Characteristics" section shows the toggle bit timing diagrams. Figure 23 shows the differences between I/O_2 and I/O_6 in graphical form. See also the subsection on I/O_2 : Toggle Bit II.



Note:

The system should recheck the toggle bit even if $I/O_5="1"$ because the toggle bit may stop toggling as I/O_5 changes to "1". See the subsections on I/O_6 and I/O_2 for more information.

Figure 6. Toggle Bit Algorithm



I/O2: Toggle Bit II

The "Toggle Bit II" on I/O₂, when used with I/O₆, indicates whether a particular sector is actively erasing (that is, the Embedded Erase algorithm is in progress), or whether that sector is erase-suspended. Toggle Bit II is valid after the rising edge of the final \overline{WE} pulse in the command sequence. I/O₂ toggles when the system reads at addresses within those sectors that have been selected for erasure. (The system may use either \overline{OE} or \overline{CE} to control the read cycles.) But I/O₂ cannot distinguish whether the sector is actively erasing or is erase-suspended. I/O₆, by comparison, indicates whether the device is actively erasing, or is in Erase Suspend, but cannot distinguish which sectors are selected for erasure. Thus, both status bits are required for sector and mode information. Refer to Table 8 to compare outputs for I/O₂ and I/O₆.

Figure 6 shows the toggle bit algorithm in flowchart form, and the section " I/O_2 : Toggle Bit II" explains the algorithm. See also the " I/O_6 : Toggle Bit I" subsection. Figure 20 shows the toggle bit timing diagram. Figure 21 shows the differences between I/O_2 and I/O_6 in graphical form.

Reading Toggle Bits I/O6, I/O2

Refer to Figure 6 for the following discussion. Whenever the system initially begins reading toggle bit status, it must read $I/O_7-I/O_0$ at least twice in a row to determine whether a toggle bit is toggling. Typically, a system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on $I/O_7-I/O_0$ on the following read cycle.

However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of I/O_5 is high (see the section on I/O_5). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as I/O_5 went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not complete the operation successfully, and the system must write the reset command to return to reading array data.

The remaining scenario is that the system initially determines that the toggle bit is toggling and I/Os has not gone high. The system may continue to monitor the toggle bit and I/Os through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other system tasks. In this case, the system must start at the beginning of the algorithm when it

returns to determine the status of the operation (top of Figure 6).

I/O5: Exceeded Timing Limits

 I/O_5 indicates whether the program or erase time has exceeded a specified internal pulse count limit. Under these conditions I/O_5 produces a "1." This is a failure condition that indicates the program or erase cycle was not successfully completed.

The device may output a "1" on I/O_5 if the system tries to program a "1" to a location that was previously programmed to "0." Only an erase operation can change a "0" back to a "1." Under this condition, the device halts the operation, and when the timing limit has been exceeded, I/O_5 produces a "1.".

Under both these conditions, the system must write the reset command to return to reading array data (or to the erasesuspend-read mode if a bank was previously in the erasesuspend-program mode).

I/O3: Sector Erase Timer

After writing a sector erase command sequence, the system may read I/O_3 to determine whether or not an erase operation has begun. (The sector erase timer does not apply to the chip erase command.) If additional sectors are selected for erasure, the entire time-out also applies after each additional sector erase command. When the time-out is complete, I/O_3 switches from "0" to "1." The system may ignore I/O_3 if the system can guarantee that the time between additional sector erase commands will always be less than 50µs. See also the "Sector Erase Command Sequence" section.

After the sector erase command sequence is written, the system should read the status on I/O₇ (Data Polling) or I/O₆ (Toggle Bit 1) to ensure the device has accepted the command sequence, and then read I/O₃. If I/O₃ is "1", the internally controlled erase cycle has begun; all further commands (Except Erase Suspend) are ignored until the erase operation is complete. If I/O₃ is "0", the device will accept additional sector erase commands. To ensure the command has been accepted, the system software should check the status of I/O₃ prior to and following each subsequent sector erase command. If I/O₃ is high on the second status check, the last command might not have been accepted.

Table 13 shows the status of I/O₃ relative to the other status bits.



| | Status | | I/O 7 | I/O6 | I/O5 | I/O3 | I/O2 | RY/BY |
|--------------------------|------------------|-----------------------------|--------------|-----------|----------|--------|-----------|-------|
| | | | | | (Note 1) | | (Note 2) | |
| Standard Mode | Embedded Program | n Algorithm | I/O7 | Toggle | 0 | N/A | No toggle | 0 |
| wode | Embedded Erase A | 0 | Toggle | 0 | 1 | Toggle | 0 | |
| Erase Suspend Mode | Erase-Suspend- | Erase Suspended Sector | 1 | No toggle | 0 | N/A | Toggle | 1 |
| | Read | Non-Erase Suspend Sector | Data | Data | Data | Data | Data | 1 |
| | Erase-Suspend-P | rogram | I/O7 | Toggle | 0 | N/A | N/A | 0 |

Table 13. Write Operation Status

Notes:

1. I/O₅ switches to '1' when an Embedded Program or Embedded Erase operation has exceeded the maximum timing limits. Refer to the section on I/O₅ for more information.

2. I/O7 and I/O2 require a valid address when reading status information. Refer to the appropriate subsection for further details.

3. When reading write operation status bits, the system must always provide the bank address where the Embedded Algorithm is in progress. The device outputs array data if the system addresses a non-busy bank.

ΔΜΙC

ABSOLUTE MAXIMUM RATINGS*

Notes:

- Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, input or I/O pins may undershoot VSS to -2.0V for periods of up to 20ns. Maximum DC voltage on input and I/O pins is VCC +0.5V. See Figure 7. During voltage transitions, input or I/O pins may overshoot to VCC +2.0V for periods up to 20ns. See Figure 8.
- Minimum DC input voltage on A9, OE, RESET and WP /ACC is -0.5V. During voltage transitions, A9, OE, WP /ACC and RESET may overshoot VSS to -2.0V for periods of up to 20ns. See Figure 7. Maximum DC input voltage on A9 is +12.5V which may overshoot to 14.0V for periods up to 20ns. Maximum DC input voltage on WP /ACC is +9.5V which may overshoot to +12.0V for period up to 20ns.
- 3. No more than one output is shorted to ground at a time. Duration of the short circuit should not be greater than one second.

Figure 7. Maximum Negative Overshoot Waveform

*Comments

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to this device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this data sheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

OPERATING RANGES

Industrial (I) Devices

| Ambient Temperature (TA) | -40°C to +85°C |
|--------------------------|----------------|
| | |

VCC Supply Voltages

VCC for all devices+2.7V to +3.6V

Operating ranges define those limits between which the functionally of the device is guaranteed.



Figure 8. Maximum Positive Overshoot Waveform





CMOS Compatible

| Parameter Symbol | Parameter Description | Test Description | | Min. | Тур. | Max. | Unit |
|---------------------|---|---|---------|------------|------|-----------|------|
| lu | Input Load Current | $V_{IN} = VSS \text{ to } VCC. VCC = V$ | /CC Max | | | ±1.0 | μA |
| Ілт | A9 Input Load Current | VCC = VCC Max, A9 =12.5 | V | | | 35 | μΑ |
| llo | Output Leakage Current | Vout = VSS to VCC. VCC = | VCC Max | | | ±1.0 | μA |
| | | $\overline{CE} = VIL, \overline{OE} = VIH$ 5 MHz | | | 10 | 16 | |
| | VCC Active Read Current | Byte Mode | 1 MHz | | 2 | 4 | |
| ICC1 | (Notes 1, 2) | | 5 MHz | | 10 | 16 | mA |
| | | Word Mode | 1 MHz | | 2 | 4 | |
| lcc2 | VCC Active Write Current (Notes 2, 3) | $\overline{CE} = VIL, \overline{OE} = VIH$ | | | 20 | 30 | mA |
| lcc3 | VCC Standby Current (Note 2) | $\overline{CE} = VIH, \overline{RESET} = VCC \pm$ | 0.3V | | 0.2 | 5 | μΑ |
| lcc4 | VCC Reset Current (Note 2) | $\overline{RESET} = VSS \pm 0.3V$ | | | 0.2 | 5 | μΑ |
| lcc5 | Automatic Sleep Mode (Note 2, 4) | $VIH = VCC \pm 0.3V; VIL = VS$ | | 0.2 | 5 | μA | |
| laan | VCC Active Read-While-Program | $\overline{CE} = V_{II} \overline{OE} = V_{III}$ | Byte | | 21 | 45 | |
| ICC6 | Current (Notes 1, 2) | | Word | | 21 | 45 | mΑ |
| 1007 | VCC Active Read-While-Erase | CE = VIL, OE = VIH Byte | | | 21 | 45 | |
| 1007 | Current (Notes 1, 2) | | Word | | 21 | 45 | |
| 1 | VCC Active | | | | 17 | 05 | |
| ICC8 | Current (Notes 2, 5) | | | | 17 | 30 | mA |
| | ACC Accelerated Program Current, | $\overline{CE} = VIL, \overline{OE} = VIH$ | ACC pin | | 5 | 10 | m۸ |
| IACC | Word or Byte | | VCC pin | | 15 | 30 | ША |
| Vil | Input Low Level | | | -0.5 | | 0.8 | V |
| Viн | Input High Level | | | 0.7 x VCC | | VCC + 0.3 | V |
| Vнн | Voltage for WP /ACC Sector Protect/Unprotect and Program Acceleration | VCC = 3.0 V ± 10% | | 8.5 | | 9.5 | V |
| Vid | Voltage for Autoselect and Temporary Unprotect Sector | VCC = 3.0 V ± 10% | | 8.5 | | 12.5 | V |
| Vol | Output Low Voltage | IoL = 4.0mA, VCC = VCC N | lin | | | 0.45 | V |
| Vон1 | | loh = -2.0 mA, VCC = VCC | Min | 0.85 x VCC | | | V |
| Vон2 | Output High Voltage | Іон = -100 μ A, VCC = VCC | Min | VCC - 0.4 | | | V |
| Vlko | Low VCC Lock-Out Voltage (Note 5) | | | 2.3 | | 2.5 | V |

Notes:

1. The lcc current listed is typically less than 2 mA/MHz, with \overline{OE} at ViH.

2. Maximum Icc specifications are tested with VCC = VCC max.

 3. Icc active while Embedded Algorithm (program or erase) is in progress.
 4. Automatic sleep mode enables the low power mode when addresses remain stable for tacc + 30ns. Typical sleep mode current is 200nA.

5. Not 100% tested.

TEST CONDITIONS

Table 14. Test Specifications

| Test Condition | -70, -80 | -90, -120 | Unit |
|--|-----------|------------|------|
| Output Load | | 1 TTL gate | |
| Output Load Capacitance, CL(including jig capacitance) | 30 | 100 | pF |
| Input Rise and Fall Times | 5 | 5 | ns |
| Input Pulse Levels | 0.0 - 3.0 | 0.0 - 3.0 | V |
| Input timing measurement reference levels | 1.5 | 1.5 | V |
| Output timing measurement reference levels | 1.5 | 1.5 | V |

Figure 9. Test Setup



Figure 10. Input Waveforms and Measurement Levels





Read Only Operations

| Parar | neter | Description | | Test Setup | | Speed | | | | Unit |
|-------|-------|---|---|------------|------|-------|-----|-----|------|------|
| JEDEC | Std | | | | | -70 | -80 | -90 | -120 | |
| tavav | trc | Read Cycle Time (No | | Min. | 70 | 80 | 90 | 120 | ns | |
| tavqv | tacc | Address to Output De | \overline{CE} =VIL \overline{OE} =VIL | Max. | 70 | 80 | 90 | 120 | ns | |
| telqv | tce | Chip Enable to Outpu | OE = VIL | Max. | 70 | 80 | 90 | 120 | ns | |
| tglqv | toe | Output Enable to Out | | Max. | 30 | 30 | 40 | 50 | ns | |
| tенqz | tdf | Chip Enable to Outpu (Notes 1,3) | | Max. | 16 | 16 | 16 | 16 | ns | |
| tgнqz | tdf | Output Enable to Output High Z (Notes 1,3) | | | Max. | 16 | 16 | 16 | 16 | ns |
| taxqx | toн | $\frac{\text{Output Hold Time fro}}{\overline{\text{CE}} \text{ or } \overline{\text{OE}}}, \text{Whichev}$ | | Min. | 0 | | | | ns | |
| | topu | Output Enable Hold | Read | | Min. | | (|) | | ns |
| | IOEH | Time (Note 1) | Toggle and Data Polling | | Min. | | 1 | 0 | | ns |

Notes:

1. Not 100% tested.

2. See Figure 9 and Table 14 for test specifications.

3. Measurements performed by placing a 50-ohm termination on the data pin with a bias of VCC/2. The time from \overline{OE} high to the data bus driven to VCC/2 is taken as tor.



Figure 11. Read Operation Timings



Hardware Reset (RESET)

| Paran | neter | Description | Tost Sotun | All Speed Options | Unit | |
|-------|---------------|--|------------|-------------------|------|--|
| JEDEC | Std | Description | Test Setup | All Speed Options | Unit | |
| | TREADY | RESET Pin Low (During Embedded Algorithms) to Read or Write (See Note) | Ma | x 20 | μS | |
| | TREADY | RESET Pin Low (Not During Embedded Algorithms) to Read or Write (See Note) | Ma | x 500 | ns | |
| | trp | RESET Pulse Width | Mir | n 500 | ns | |
| | trн | RESET High Time Before Read (See Note) | Mir | n 50 | ns | |
| | trв | RY/BY Recovery Time | Mir | 0 | ns | |
| | t RPD | RESET Low to Standby Mode | Mir | 20 | μS | |

Note: Not 100% tested.

Figure 12. RESET Timings



Word/Byte Configuration (BYTE)

| Parameter | | Description | | All Speed Options | | | | Unit |
|-----------|-------------|--|-----|-------------------|-----|-----|------|------|
| JEDEC | Std | | | -70 | -80 | -90 | -120 | |
| | telfl/telfh | \overline{CE} to \overline{BYTE} Switching Low or High | Max | 5 | | | ns | |
| | tflqz | BYTE Switching Low to Output High-Z | Max | 25 | 25 | 30 | 30 | ns |
| | thav | BYTE Switching High to Output Active | Min | 70 | 80 | 90 | 120 | ns |

Figure 13. BYTE Timings for Read Operations



Figure 14. BYTE Timings for Write Operations

Note:

Refer to the Erase/Program Operations table for tas and tan specifications.

Erase and Program Operations

| Parameter | | Description | | | Speed | | | | Unit |
|---------------|----------|--|-------------------|------|-------|-----|-----|------|------|
| JEDEC | Std | - | | | -70 | -80 | -90 | -120 | |
| tavav | twc | Write Cycle Time (Note 1) | | | 70 | 80 | 90 | 120 | ns |
| tavw∟ | tas | Address Setup Time | | Min. | | | 0 | | ns |
| | taso | Address Setup Time to $\overline{\text{OE}}$ low polling | during toggle bit | | 15 | 15 | 15 | 15 | ns |
| tw∟ax | tан | Address Hold Time | | Min. | 45 | 45 | 45 | 50 | ns |
| | tант | Address Hold Time From \overline{CE} or toggle bit polling | OE high during | | 0 | | | | ns |
| tdvwн | tos | Data Setup Time | | Min. | 35 | 35 | 45 | 50 | ns |
| twнdx | tdн | Data Hold Time | | Min. | 0 | | | | ns |
| | tоерн | Output Enable High during toggle | e bit polling | Min. | 20 | 20 | 20 | 20 | ns |
| tgнw∟ | tgнw∟ | Read Recover Time Before Write (OE high to WE low) | | | 0 | | | | ns |
| telwl | tcs | CE Setup Time | | Min. | 0 | | | | ns |
| twнен | tсн | CE Hold Time | | Min. | 0 | | | | ns |
| tw∟wн | twp | Write Pulse Width | | Min. | 30 | 30 | 35 | 50 | ns |
| twhd L | twpн | Write Pulse Width High | | Min. | 30 | 30 | 30 | 30 | ns |
| | tsr/w | Latency Between Read and Writ | e Operations | Min. | 0 | | | | |
| 4 | 4 | Byte Programming Operation | Byte | Тур. | 5 | | | | |
| LWHWH1 | IWHWH1 | (Note 2) Word | | Тур. | 7 | | | | μs |
| twhwh1 | twhwh1 | Accelerated Programming Operation, Word or Byte (Note 2) | | | 4 | | | | sec |
| twнwн2 | twнwн2 | Sector Erase Operation (Note 2) | | | 0.7 | | | | sec |
| | tvcs | VCC Set Up Time (Note 1) | | | 50 | | | | μS |
| | trв | Recovery Time from RY/\overline{BY} | | Min | 0 | | | | ns |
| | tBUSY | Program/Erase Valid to RY/BY | Delay | Min | | g | 00 | | ns |

Notes:

1. Not 100% tested.

2. See the "Erase and Programming Performance" section for more information.

Figure 15. Program Operation Timings

Note :

1. PA = program address, PD = program data, Dout is the true data at the program address.

2. Illustration shows device in word mode.

Figure 17. Chip/Sector Erase Operation Timings

Note :

SA = Sector Address (for Sector Erase), VA = Valid Address for reading status data (see "Write Operation Ststus").
 Illustration shows device in word mode.

Figure 18. Back-to-back Read/Write Cycle Timings

Figure 19. Data Polling Timings (During Embedded Algorithms)

Note : VA = Valid Address. Illustation shows first status cycle after command sequence, last status read cycle, and array data read cycle.

Figure 20. Toggle Bit Timings (During Embedded Algorithms)

Note: VA = Valid Address; not required for I/O₆. Illustration shows first two status cycle after command sequence, last status read cycle, and array data read cycle.

Figure 21. I/O2 vs. I/O6

Note : Both I/O₆ and I/O₂ toggle with \overline{OE} or \overline{CE} . See the text on I/O₆ and I/O₂ in the section "Write Operation Status" for more information.

Temporary Sector/Sector Block Unprotect

| Parameter | | Description | | All Speed Options | Unit |
|-----------|-------|--|-----|-------------------|------|
| JEDEC | Std | Description | | | onin |
| | tvidr | Vid Rise and Fall Time (See Note) | Min | 500 | ns |
| | tvнн | Vнн Rise and Fall Time (See Note) | Min | 250 | μs |
| | trsp | RESET Setup Time for Temporary Sector/Sector Block Unprotect | Min | 4 | μs |
| | trrв | RESET Hold Time from RY/BY High for Temporary Sector/Sector Block Unprotect | Min | 4 | μs |

Note: Not 100% tested.

Figure 22. Temporary Sector/Sector Block Unprotect Timing Diagram

Figure 23. Sector/Sector Block Protect and Unprotect Timing Diagram

Alternate $\overline{\text{CE}}$ Controlled Erase and Program Operations

| Parameter | | Description | | | Speed | | | | Unit |
|--------------|---------------|--|------|------|-------|-----|------|-----|------|
| JEDEC | Std | | | -70 | -80 | -90 | -120 | | |
| tavav | twc | Write Cycle Time (Note 1) | | Min. | 70 | 80 | 90 | 120 | ns |
| TAVEL | tas | Address Setup Time | | Min. | | (|) | | ns |
| telax | tан | Address Hold Time | | Min. | 45 | 45 | 45 | 50 | ns |
| tdveн | tos | Data Setup Time | | Min. | 35 | 35 | 45 | 50 | ns |
| tendx | tdн | Data Hold Time | | Min. | | (|) | | ns |
| tghel | t GHEL | Read Recover Time Before Wri (\overline{OE} High to \overline{WE} Low) | Min. | 0 | | | | ns | |
| twlel | tws | WE Setup Time | | Min. | 0 | | | | ns |
| tенwн | twн | WE Hold Time | | Min. | 0 | | | | ns |
| tеген | tcp | CE Pulse Width | | Min. | 30 | 30 | 45 | 50 | ns |
| TEHEL | tсрн | CE Pulse Width High | | Min. | 30 | 30 | 30 | 30 | ns |
| | they may be | Programming Operation Byte | | Тур. | 5 | | | | μS |
| (WHWH) | | (Note 2) Word | | Тур. | 7 | | | | |
| twhwh1 | twnwn1 | Accelerated Programming Operation, Word or Byte (Note 2) | | Тур. | 4 | | | | μS |
| twнwн2 | twнwн2 | Sector Erase Operation (Note 2 |) | Тур. | | 0 | .7 | | sec |

Notes:

1. Not 100% tested.

2. See the "Erase and Programming Performance" section for more information.

Figure 24. Alternate CE Controlled Write (Erase/Program) Operation Timings

Notes:

- 1. Figure indicates last two bus cycles of a program or erase operation.
- 2. PA = program address, SA = sector address, PD = program data.
- 3. $\overline{I/O_7}$ is the complement of the data written to the device. Dout is the data written to the device.
- 4. Waveforms are for the word mode.

ERASE AND PROGRAMMING PERFORMANCE

| Parameter | Typ. (Note 1) | Max. (Note 2) | Unit | Comments | | |
|-----------------------------|---------------|---------------|------|--|---------------------------|--|
| Sector Erase Time | 0.7 | 15 | sec | Excludes 00h programming | | |
| Chip Erase Time | | 27 | | sec | prior to erasure (Note 4) | |
| Byte Programming Time | 5 | 150 | μS | | | |
| Word Programming Time | 7 | 210 | μS | | | |
| Accelerated Word/Byte Progr | 4 | 120 | μS | Excludes system-level overhead (Note 5) | | |
| Chip Programming Time | Byte Mode | 9 | 27 | sec | | |
| (Note 3) | Word Mode | 6 | 18 | sec | | |

Notes:

1. Typical program and erase times assume the following conditions: 25°C, 3.0V VCC, 10,000 cycles. Additionally, programming typically assumes checkerboard pattern.

2. Under worst case conditions of 90° C, VCC = 2.7V, 100,000 cycles.

3. The typical chip programming time is considerably less than the maximum chip programming time listed, since most bytes program faster than the maximum byte program time listed.

4. In the pre-programming step of the Embedded Erase algorithm, all bytes are programmed to 00h before erasure.

5. System-level overhead is the time required to execute the four-bus-cycle command sequence for programming. See Table 12 for further information on command definitions.

6. The device has a minimum erase and program cycle endurance of 10,000 cycles.

LATCH-UP CHARACTERISTICS

| Description | Min. | Max. |
|---|---------|----------|
| Input Voltage with respect to VSS on all I/O pins | -1.0V | VCC+1.0V |
| VCC Current | -100 mA | +100 mA |
| Input voltage with respect to VSS on all pins except I/O pins (including A9, \overline{OE} and \overline{RESET}) | -1.0V | 12.5V |

Includes all pins except VCC. Test conditions: VCC = 3.0V, one pin at time.

PACKAGE AND PIN CAPACITANCE

| Parameter Symbol | Parameter Description | Test Setup | | Тур. | Max. | Unit |
|------------------|-------------------------|------------|--------|------|------|------|
| Chi | Input Consoitance | V/m. O | TSOP | 6 | 7.5 | pF |
| CIN | Input Capacitance | VIN=U | TF BGA | 4.2 | 5 | pF |
| 0 | Output Capacitance | Vout=0 | TSOP | 8.5 | 12 | pF |
| Cour | | | TF BGA | 5.4 | 6.5 | pF |
| 0 | | | TSOP | 7.5 | 9 | pF |
| CIN2 | Control Pin Capacitance | VIN=U | TF BGA | 3.9 | 4.7 | pF |

Notes:

1. Sampled, not 100% tested.

2. Test conditions $T_A = 25^{\circ}C$, f = 1.0MHz

DATA RETENTION

| Parameter | Test Conditions | Min | Unit |
|-------------------------------------|-----------------|-----|-------|
| | 150°C | 10 | Years |
| Minimum Pattern Data Retention Time | 125°C | 20 | Years |

Ordering Information

Top Boot Sector Flash

| Part No. | Access Time (ns) | Active Read Current Typ. (mA) | Program/Erase Current Typ. (mA) | Standby Current Typ. (μΑ) | Package |
|----------------|---------------------|-------------------------------------|---------------------------------------|------------------------------|---------------|
| A29DL322TV-70 | 70 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322TG-70 | 70 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL322TV-80 | 80 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322TG-80 | 00 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL322TV-90 | 00 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322TG-90 | 90 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL322TV-120 | 120 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322TG-120 | 120 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323TV-70 | 70 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323TG-70 | 70 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323TV-80 | 80 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323TG-80 | 00 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323TV-90 | 00 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323TG-90 | 90 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323TV-120 | 120 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323TG-120 | 120 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL324TV-70 | 70 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324TG-70 | 70 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL324TV-80 | 80 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324TG-80 | 00 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL324TV-90 | 00 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324TG-90 | 90 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL324TV-120 | 120 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324TG-120 | 120 | 10 | 20 | 0.2 | 48 ball TFBGA |

Ordering Information (continued) Bottom Boot Sector Flash

| Part No. | Access Time (ns) | Active Read Current Typ. (mA) | Program/Erase Current Typ. (mA) | Standby Current Typ. (μΑ) | Package |
|----------------|---------------------|-------------------------------------|---------------------------------------|------------------------------|---------------|
| A29DL322UV-70 | 70 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322UG-70 | 70 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL322UV-80 | 80 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322UG-80 | 80 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL322UV-90 | 90 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322UG-90 | 90 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL322UV-120 | 120 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL322UG-120 | 120 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323UV-70 | 70 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323UG-70 | 70 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323UV-80 | 80 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323UG-80 | 00 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323UV-90 | 00 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323UG-90 | 90 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL323UV-120 | 120 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL323UG-120 | 120 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL324UV-70 | 70 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324UG-70 | 70 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL324UV-80 | 80 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324UG-80 | 00 | 10 | 20 | 0.2 | 48 ball TFBGA |
| A29DL324UV-90 | 00 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324UG-90 | 30 | ĨŬ | 20 | 0.2 | 48 ball TFBGA |
| A29DL324UV-120 | 120 | 10 | 20 | 0.2 | 48 pin TSOP |
| A29DL324UG-120 | 120 | 10 | 20 | 0.2 | 48 ball TFBGA |

Package Information

TSOP 48L (Type I) Outline Dimensions

unit: inches/mm

| Symbol | Dimen | sions in | inches | Dimensions in mm | | | |
|--------|------------|-----------|--------|------------------|-------|-------|--|
| Symbol | Min | Nom | Max | Min | Nom | Max | |
| А | - | - | 0.047 | - | - | 1.20 | |
| A1 | 0.002 | - | 0.006 | 0.05 | - | 0.15 | |
| A2 | 0.037 | 0.039 | 0.042 | 0.94 | 1.00 | 1.06 | |
| b | 0.007 | 0.009 | 0.011 | 0.18 | 0.22 | 0.27 | |
| С | 0.004 | - | 0.008 | 0.12 | - | 0.20 | |
| D | 0.779 | 0.787 | 0.795 | 19.80 | 20.00 | 20.20 | |
| D1 | 0.720 | 0.724 | 0.728 | 18.30 | 18.40 | 18.50 | |
| E | - | 0.472 | 0.476 | - | 12.00 | 12.10 | |
| е | 0. | .020 BASI | С | 0.50 BASIC | | | |
| L | 0.016 | 0.020 | 0.024 | 0.40 | 0.50 | 0.60 | |
| S | 0.011 Typ. | | | 0.28 Typ. | | | |
| у | - | - | 0.004 | - | - | 0.10 | |
| θ | 0° | - | 8° | 0° | - | 8° | |

Notes:

1. The maximum value of dimension D includes end flash.

2. Dimension E does not include resin fins.

3. Dimension S includes end flash.

Package Information

48LD CSP (6 x 8 mm) Outline Dimensions (48TFBGA)

TOP VIEW

| 0h.al | Dimensions in mm | | | | |
|--------|------------------|-----------|------|--|--|
| Symbol | Min. | Min. Nom. | | | |
| А | - | - | 1.20 | | |
| A1 | 0.20 | 0.25 | 0.30 | | |
| b | 0.30 | - | 0.40 | | |
| D | 5.90 6.00 | | 6.10 | | |
| D1 | 4.00 BSC | | | | |
| е | - | 0.80 | - | | |
| E | 7.90 | 8.00 | 8.10 | | |
| E1 | 5.60 BSC | | | | |

unit: mm